



HAC RF TEST REPORT

No. 2013EEB00057-1

For

Emporia Telecom USA Inc

GSM Dual Band Mobile Phone

Model name: VF4

Marketing Name :RL2

With

Hardware Version: VF4__MB_V2.0

Software Version: VF4_USA_NW_TFT_130218

FCC ID: ZVP-RL2

Results Summary: M Category = M3 (for GSM 850/1900)

Issued Date: 2013-03-08

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of TMC Beijing.

Test Laboratory:

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1 Test Laboratory

1.1 Testing Location

Company Name: TMC Shenzhen, Telecommunication Metrology Center of MIIT
Address: No. 12building, Shangsha Innovation and Technology Park, Futian District, Shenzhen, P. R. China
Postal Code: 518048
Telephone: +86-755-33322000
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1.2 Testing Environment

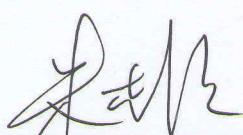
Temperature: 18°C~25 °C,
Relative humidity: 30%~ 70%
Ground system resistance: < 0.5 Ω

Ambient noise is checked and found very low and in compliance with requirement of standards.
Reflection of surrounding objects is minimized and in compliance with requirement of standards.

1.3 Project Data

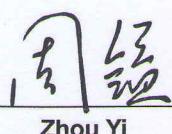
Project Leader: Zhou Yi
Test Engineer: Zhu Zhiqiang
Testing Start Date: Mar 04th, 2013
Testing End Date: Mar 04th, 2013

1.4 Signature



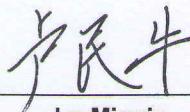
Zhu Zhiqiang

(Prepared this test report)



Zhou Yi

(Reviewed this test report)



Lu Minniu

Director of the laboratory
(Approved this test report)

2 Client Information

2.1 Applicant Information

Company Name: Emporia Telecom USA Inc
Address /Post: 321 E. Glen Ave, Ridgewood
City: New Jersey
Postal Code: /
Country: Silva Hoo
Contact: foley@emporiatelecom.com
E-mail: USA
Telephone: 201-962-5550
Fax: /

2.2 Manufacturer Information

Company Name: Emporia Telecom USA Inc
Address /Post: 321 E. Glen Ave, Ridgewood
City: New Jersey
Postal Code: /
Country: Silva Hoo
Contact: foley@emporiatelecom.com
E-mail: USA
Telephone: 201-962-5550
Fax: /

3 Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1 About EUT

Description:	GSM quad band mobile phone
Model name:	VF4
Marketing name:	RL2
Operating mode(s):	GSM 850/1900
Tested Tx Frequency:	825 – 848.8 MHz (GSM 850) 1850.2 – 1910 MHz (GSM 1900)
Test Modulation	(GSM)GMSK;
Power class:	GSM850: tested with power level 5 GSM1900: tested with power level 0
Test device Production information:	Production unit
Device type:	Portable device
Antenna type:	Integrated antenna



Figure 3.1 Constituents of the sample (Lithium Battery is in the Handset)

3.2 Internal Identification of EUT used during the test

EUT ID*	SN or IMEI	HW Version	SW Version
EUT1	353060025208913	VF4_MB_V2.0	VF4_USA_NW_TFT_130218

*EUT ID: is used to identify the test sample in the lab internally.

3.3 Internal Identification of AE used during the test

AE ID*	Description	Model	SN	Manufacturer
AE1	Battery	AK-RL2	/	Shenzhen Renergy Technology Co. Ltd

4 CONDUCTED OUTPUT POWER MEASUREMENT

4.1 Summary

During the process of testing, the EUT was controlled via Rhode & Schwarz Digital Radio Communication tester (CMU-200) to ensure the maximum power transmission and proper modulation. This result contains conducted output power for the EUT. In all cases, the measured output power should be greater and within 5% than EMI measurement.

4.2 Conducted Power

GSM 850MHz	Conducted Power (dBm)		
	Channel 251(848.8MHz)	Channel 190(836.6MHz)	Channel 128(824.2MHz)
	32.81	32.28	32.77
GSM 1900MHz	Conducted Power (dBm)		
	Channel 810(1909.8MHz)	Channel 661(1880MHz)	Channel 512(1850.2MHz)
	29.45	30.01	30.33

5. Reference Documents

5.1 Reference Documents for testing

The following document listed in this section is referred for testing.

Reference	Title	Version
ANSI C63.19-2007	American National Standard for Methods of Measurement of Compatibility between Wireless Communication Devices and Hearing Aids	2007 Edition

6 OPERATIONAL CONDITIONS DURING TEST

6.1 HAC MEASUREMENT SET-UP

These measurements are performed using the DASY5 NEO automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and remote control, is used to drive the robot motors. The PC consists of the HP Intel Core2 1.86 GHz computer with Windows XP system and HAC Measurement Software DASY5 NEO, A/D interface card, monitor, mouse, and keyboard. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

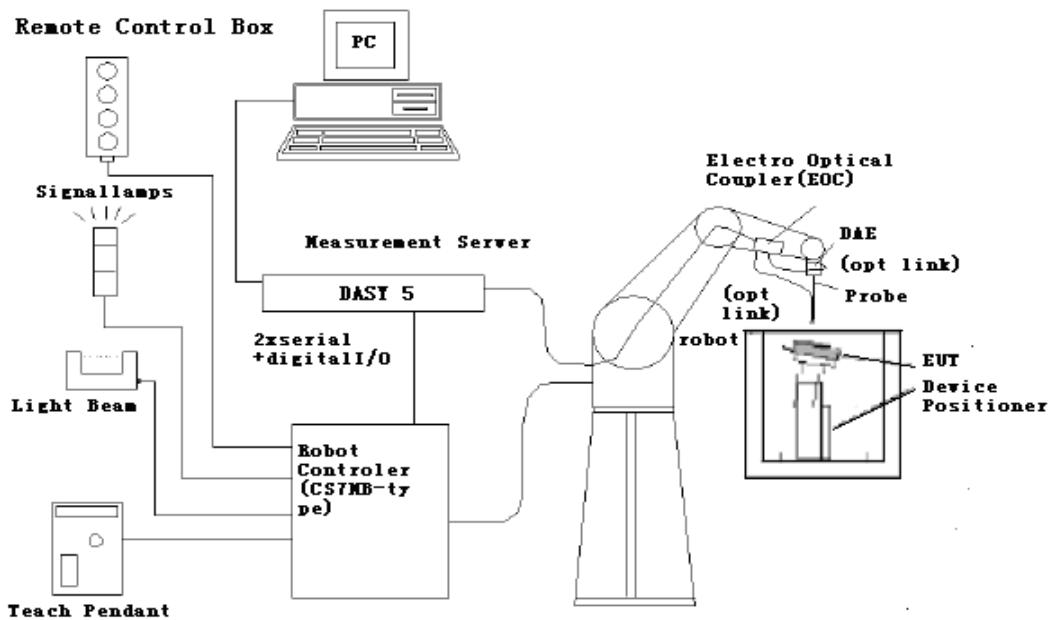


Fig. 1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

6.2 Probe Specification

6.2.1 E-Field Probe Description

Construction	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material
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[ER3DV6]

Calibration	In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$, k=2)
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Frequency	40 MHz to > 6 GHz (can be extended to < 20 MHz) Linearity: ± 0.2 dB (100 MHz to 3 GHz)
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Directivity	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)
-------------	---

Dynamic Range	2 V/m to > 1000 V/m; Linearity: ± 0.2 dB
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Dimensions	Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm
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Application	General near-field measurements up to 6 GHz Field component measurements Fast automatic scanning in phantoms
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6.2.2 H-Field Probe Description

Construction	Three concentric loop sensors with 3.8 mm loop diameters Resistively loaded detector diodes for linear response Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycoether)
Frequency	200 MHz to 3 GHz (absolute accuracy $\pm 6.0\%$, k=2); Output linearized
Directivity	± 0.2 dB (spherical isotropy error)
Dynamic Range	10 mA/m to 2 A/m at 1 GHz
E-Field Interference	< 10% at 3 GHz (for plane wave)
Dimensions	Overall length: 330 mm (Tip: 40 mm) Tip diameter: 6 mm (Body: 12 mm) Distance from probe tip to dipole centers: 3 mm
Application	General magnetic near-field measurements up to 3 GHz (in air or liquids) Field component measurements Surface current measurements Low interaction with the measured field

**[H3DV6]**

6.3 Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: 370 x 370 x 370 mm).

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field $<\pm 0.5$ dB.



Fig. 2 HAC Phantom & Device Holder

6.4 Robotic System Specifications

Specifications

Positioner: Stäubli Unimation Corp. Robot Model: TX90L

Repeatability: ± 0.02 mm

No. of Axis: 6

Data Acquisition Electronic (DAE) System

Cell Controller

Processor: Intel Core2

Clock Speed: 1.86 GHz

Operating System: Windows XP

Data Converter

Features: Signal Amplifier, multiplexer, A/D converter, and control logic

Software: DASY5 software

Connecting Lines: Optical downlink for data and status info.

Optical uplink for commands and clock

7 EUT ARRANGEMENT

7.1 WD RF Emission Measurements Reference and Plane

Figure 4 illustrates the references and reference plane that shall be used in the WD emissions measurement.

- The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids.
- The grid is centered on the audio frequency output transducer of the WD (speaker or T-coil).
- The grid is located by reference to a reference plane. This reference plane is the planar area that contains the highest point in the area of the WD that normally rests against the user's ear

- The measurement plane is located parallel to the reference plane and 15 mm from it, out from the phone. The grid is located in the measurement plane.

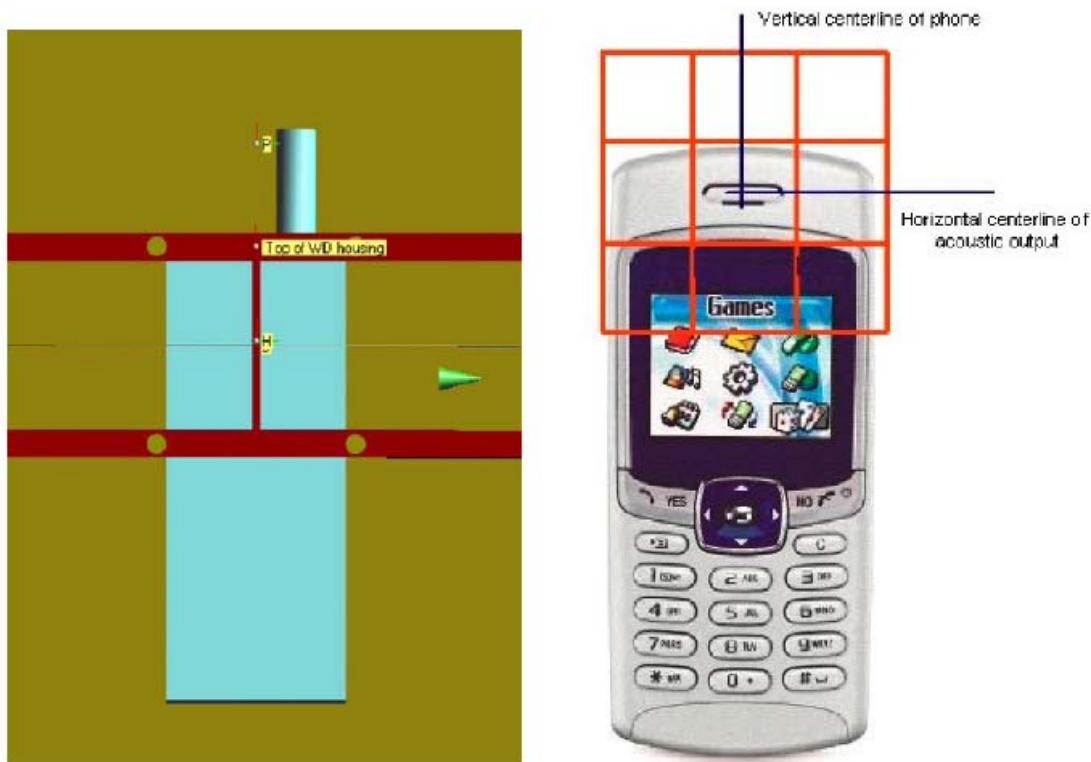


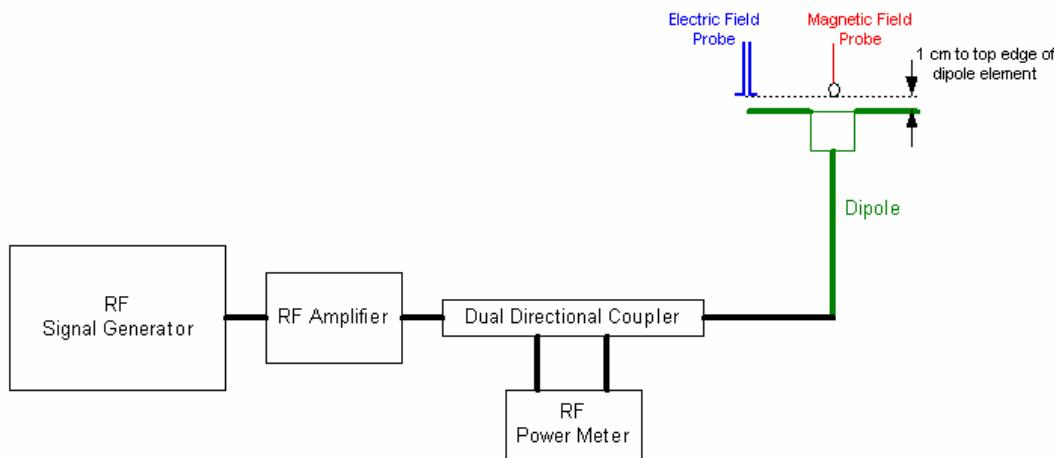
Fig. 3 WD reference and plane for RF emission measurements

8 SYSTEM VALIDATION

8.1 Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 D.5 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical and magnetic output. Position the E-field and H-field probes so that:

- The probes and their cables are parallel to the coaxial feed of the dipole antenna
- The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions
- The center point of the probe element(s) are 10 mm from the closest surface of the dipole elements.


Fig. 4 Dipole Validation Setup

8.2 Validation Result

E-Field Scan							
Mode	Frequency (MHz)	Input Power (mW)	Measured ¹ Value(V/m)	Target ² Value(V/m)	Deviation ³ (%)	Limit ⁴ (%)	
CW	835	100	162.8	160.7	1.31	± 25	
CW	1880	100	143.8	141.5	1.63	± 25	
H-Field Scan							
Mode	Frequency (MHz)	Input Power (mW)	Measured Value(A/m)	Target Value(A/m)	Deviation (%)	Limit (%)	
CW	835	100	0.465	0.456	1.97	± 25	
CW	1880	100	0.464	0.473	-1.90	± 25	

Notes:

1. Please refer to the attachment for detailed measurement data and plot.
2. Target value is provided by SPEAD in the calibration certificate of specific dipoles.
3. Deviation (%) = $100 * (\text{Measured value} - \text{Target value}) / \text{Target value}$.
4. ANSI C63.19 requires values within $\pm 25\%$ are acceptable, of which 12% is deviation and 13% is measurement uncertainty. Values independently validated for the dipole actually used in the measurements should be used, when available.

9 Probe Modulation Factor

The Probe Modulation Factor (PMF) is defined as the ratio of the field readings for a CW and a modulated signal with the equivalent Field Envelope Peak as defined in ANSI C63.19 (Chapter C.3.1). Calibration shall be made of the modulation response of the probe and its instrumentation chain. This Calibration shall be performed with the field probe, attached to the instrumentation that is to be used with it during the measurement. The response of the probe system to a CW field at the frequency(s) of interest is compared to its response to a modulated signal with equal peak amplitude. The field level of the test signals shall be more than 10dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated field shall be applied to the readings taken of modulated fields of the specified type.

9.1 Modulation Factor Test Procedure

This may be done using the following procedure:

1. Fix the field probe in a set location relative to a field generating device, such as the reference dipole antenna, as illustrated in Figure 6.
2. Illuminate the probe using the wireless device connected to the reference dipole with a test signal at the intended measurement frequency. Ensure there is sufficient field coupling between the probe and the antenna so the resulting reading is greater than 10 dB above the probe system noise floor but within the systems operating range.
3. Record the amplitude applied to the antenna during transmission and the field strength measured by the E-field probe located near the tip of the dipole antenna
4. Replace the wireless device with an RF signal generator producing an unmodulated CW signal and set to the wireless device operating frequency.
5. Set the amplitude of the unmodulated signal to equal that recorded from the wireless device.
6. Record the reading of the probe measurement system of the unmodulated signal.
7. The ratio, in linear units, of the probe reading in Step 6) to the reading in Step 3) is the E-field modulation factor. $PMF_E = E_{CW} / E_{mod}$ ($PMF_H = H_{CW} / H_{mod}$)
8. Repeat the previous steps using the H-field probe, except locate the probe at the center of the dipole.

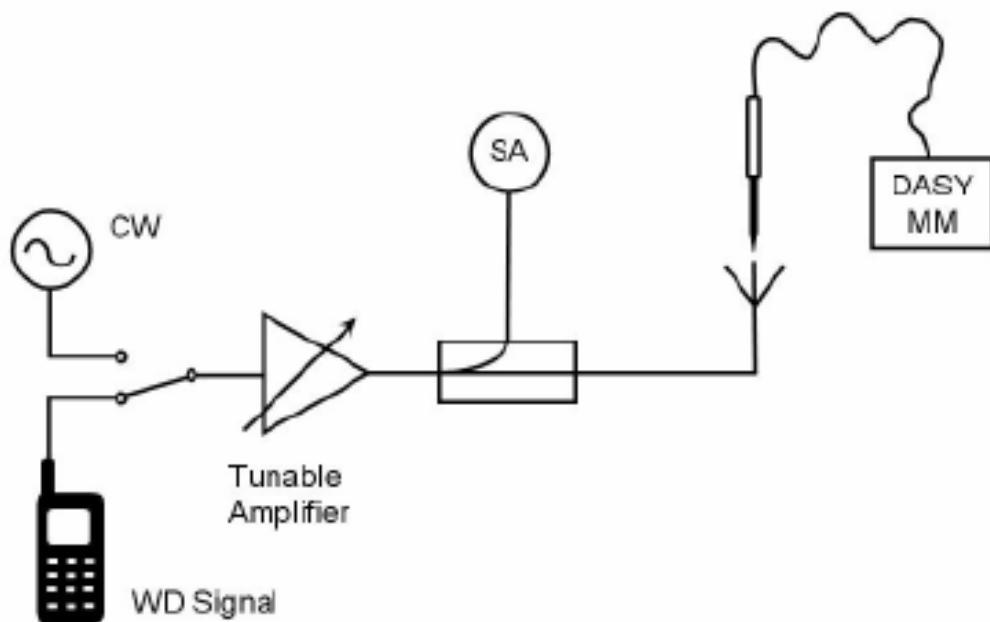


Fig. 5 Probe Modulation Factor Test Setup

9.2 Modulation Factor

9.2.1 E-Field

Frequency (MHz)	Mode	Input Power (mW)	E-Field Measured Value (V/m)	Probe Modulation Factor
835	CW	100	164.8	\
	GSM	100	58.1	2.88
1880	CW	100	143.2	\
	GSM	100	47.2	2.88

9.2.2 H-Field

Frequency (MHz)	Mode	Input Power (mW)	H-Field Measured Value (A/m)	Probe Modulation Factor
835	CW	100	0.468	\
	GSM	100	0.142	2.88
1880	CW	100	0.461	\
	GSM	100	0.148	2.88

10 RF TEST PROCEDURES

The evaluation was performed with the following procedure:

- 1) Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
- 2) Position the WD in its intended test position. The gauge block can simplify this positioning. Note that a separate E-field and H-field gauge block will be needed if the center of the probe sensor elements are at different distances from the tip of the probe.

- 3) Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
- 4) The center sub-grid shall centered on the center of the T-Coil mode axial measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.
- 5) Record the reading.
- 6) Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
- 7) Identify the five contiguous sub-grids around the center sub-grid with the lowest maximum field strength readings. Thus the six areas to be used to determine the WD's highest emissions are identified and outlined for the final manual scan. Please note that a maximum of five blocks can be excluded for both E-field and H-field measurements for the WD output being measured. Stated another way, the center sub-grid and three others must be common to both the E-field and H-field measurements.
- 8) Identify the maximum field reading within the non-excluded sub-grids identified in Step 7)
- 9) Convert the maximum field strength reading identified in Step 8) to V/m or A/m, as appropriate. For probes which require a probe modulation factor, this conversion shall be done using the appropriate probe modulation factor and the calibration.
- 10) Repeat Step 1) through Step 10) for both the E-field and H-field measurements.
- 11) Compare this reading to the categories in ANSI C63.19 Clause 7 and record the resulting category. The lowest category number listed in 7.2, Table 7.4, or Table 7.5 obtained in Step 10) for either E- or H-field determines the M category for the audio coupling mode assessment. Record the WD category rating.

11 HAC RF TEST DATA SUMMARY

11.1 Measurement Results (E-Field)

Frequency		AWF	Measured Value (V/m)	Power Drift (dB)	Category
MHz	Channel				
GSM 850					
848.8	251	-5	211.8	-0.04	M3 (see Fig B.1)
836.6	190	-5	205.2	-0.02	M3 (see Fig B.2)
824.2	128	-5	196.1	-0.05	M3 (see Fig B.3)
GSM 1900					
1909.8	810	-5	67.43	0.00	M3 (see Fig B.4)
1880	661	-5	74.57	0.01	M3 (see Fig B.5)
1850.2	512	-5	83.68	0.01	M3 (see Fig B.6)

11.2 Measurement Results (H-Field)

Frequency		AWF	Measured Value (A/m)	Power Drift (dB)	Category
MHz	Channel				
GSM 850					
848.8	251	-5	0.2605	0.03	M4(see Fig B.7)
836.6	190	-5	0.2375	0.03	M4(see Fig B.8)
824.2	128	-5	0.2213	-0.11	M4(see Fig B.9)
GSM 1900					
1909.8	810	-5	0.1662	0.06	M3(see Fig B.10)
1880	661	-5	0.1757	0.02	M3(see Fig B.11)
1850.2	512	-5	0.1917	0.04	M3(see Fig B.12)

11.3 Total M-rating

Mode	Maximum value of peak Total E-Field (V/m)	Maximum value of peak Total H-Field (A/m)	E-Field M Rating	H-Field M Rating	Total M Rating
GSM 850	211.8	0.2605	M3 (AWF -5 dB)	M4 (AWF -5 dB)	M3(see Fig B.13)
GSM 1900	83.68	0.1917	M3 (AWF -5 dB)	M3 (AWF -5 dB)	M3(see Fig B.14)

12 ANSI C 63.19-2007 LIMITS

Table 1: Telephone near-field categories in linear units

Category		Telephone RF parameters < 960 MHz			
Near field	AWF	E-field emissions		H-field emissions	
Category M1/T1	0	631.0 to 1122.0	V/m	1.91 to 3.39	A/m
	-5	473.2 to 841.4	V/m	1.43 to 2.54	A/m
Category M2/T2	0	354.8 to 631.0	V/m	1.07 to 1.91	A/m
	-5	266.1 to 473.2	V/m	0.80 to 1.43	A/m
Category M3/T3	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m
	-5	149.6 to 266.1	V/m	0.45 to 0.80	A/m
Category M4/T4	0	< 199.5	V/m	< 0.60	A/m
	-5	< 149.6	V/m	< 0.45	A/m
Category		Telephone RF parameters > 960 MHz			
Near field	AWF	E-field emissions		H-field emissions	
Category M1/T1	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m
	-5	149.6 to 266.1	V/m	0.45 to 0.80	A/m
Category M2/T2	0	112.2 to 199.5	V/m	0.34 to 0.60	A/m
	-5	84.1 to 149.6	V/m	0.25 to 0.45	A/m
Category M3/T3	0	63.1 to 112.2	V/m	0.19 to 0.34	A/m

	-5	47.3 to 84.1	V/m	0.14 to 0.25	A/m
Category M4/T4	0	< 63.1	V/m	< 0.19	A/m
	-5	< 47.3	V/m	< 0.14	A/m

13 MEASUREMENT UNCERTAINTY

16	Device Positioning Vertical	B	4.7	R	$\sqrt{3}$	1	0.67	2.7	1.8	∞
17	Device Positioning Lateral	B	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	∞
18	Device Holder and Phantom	B	2.4	R	$\sqrt{3}$	1	1	1.4	1.4	∞
19	Power Drift	B	5.0	R	$\sqrt{3}$	1	1	2.9	2.9	∞
Phantom and Setup related										
20s	Phantom Thickness	B	2.4	R	$\sqrt{3}$	1	0.67	1.4	0.9	∞
Combined standard uncertainty(%)							14.7	10.9		
Expanded uncertainty (confidence interval of 95 %)		$u_e = 2u_c$		N	k=2		29.4	21.8		

14 MAIN TEST INSTRUMENTS

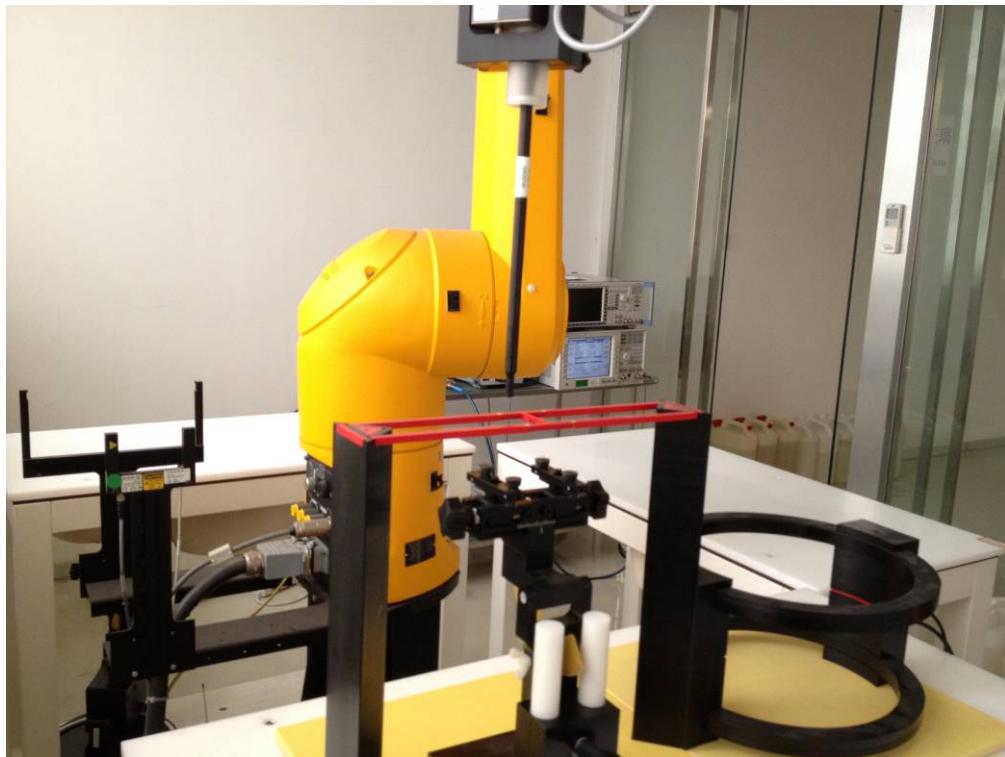
Table 2: List of Main Instruments

No.	Name	Type	Serial Number	Calibration Date	Valid Period
01	E-Field Probe	ER3DV6	2424	July 18, 2012	One year
02	H-Field Probe	H3DV6	6264	July 18, 2012	One year
03	HAC Dipole	CD835V3	1023	August 30, 2012	One year
04	HAC Dipole	CD1880V3	1018	August 30, 2012	One year
05	BTS	E5515C	GB47460133	September 20, 2012	One year
06	DAE	DAE4	786	November 20, 2012	One year

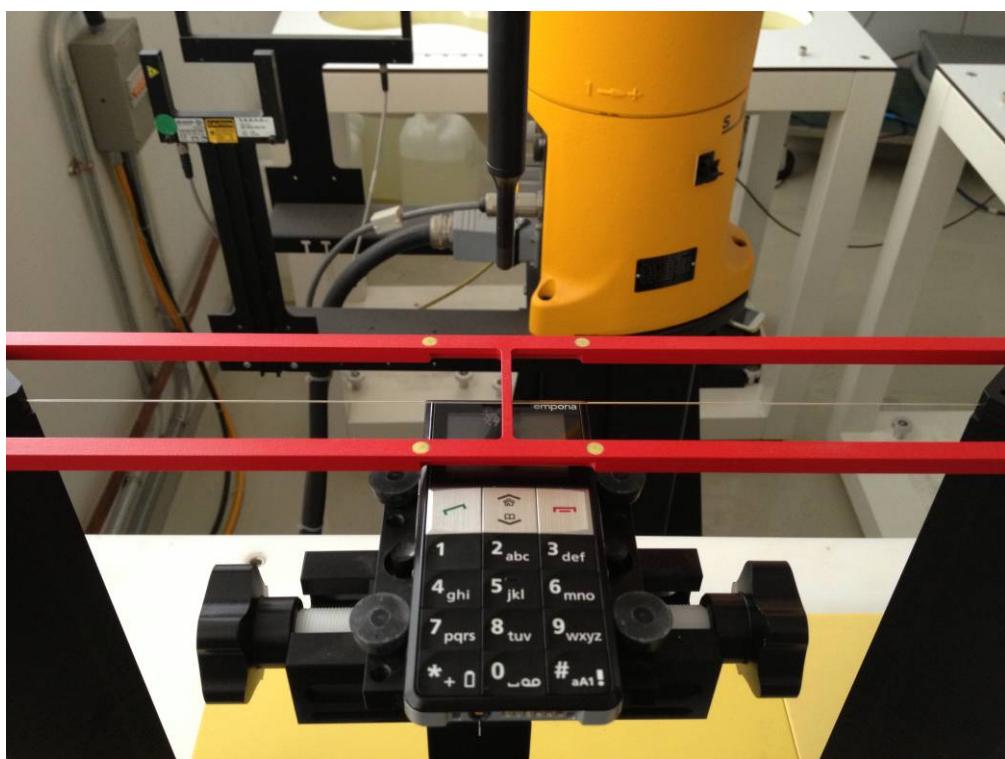
15 CONCLUSION

The HAC measurement indicates that the EUT complies with the HAC limits of the ANSI C63.19-2007. The total M-ratings are **M3** for **GSM 850/1900**.

END OF REPORT BODY

ANNEX A TEST LAYOUT

Picture A1: HAC RF System Layout



Picture A2: HAC RF Set-up

ANNEX B TEST PLOTS

HAC RF E-Field GSM 850 High

Date/Time: 3/4/2013 4:43:50 PM

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 848.8 MHz Duty Cycle: 1:8.30042

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1); Calibrated: 7/18/2012

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E

Scan GSM850 Channel High/Hearing Aid Compatibility Test (101x101x1): Interpolated

grid: $dx=0.5000 \text{ mm}$, $dy=0.5000 \text{ mm}$

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 101.0 V/m; Power Drift = -0.04 dB

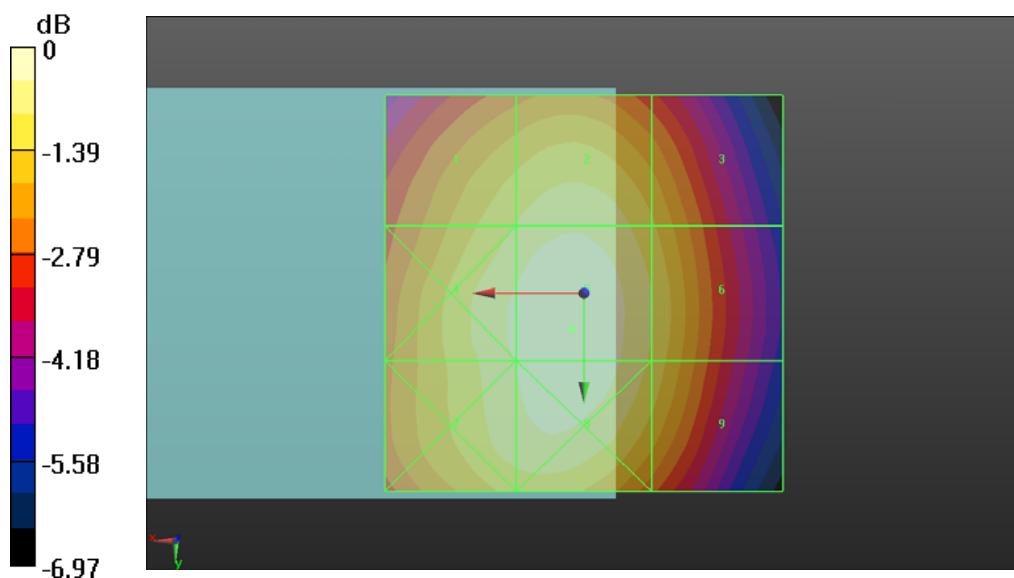
PMR not calibrated. PMF = 2.881 is applied.

E-field emissions = 211.8 V/m

Near-field category: M3 (AWF -5 dB)

PMF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
191.2 V/m	199.8 V/m	182.5 V/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
203.3 V/m	211.8 V/m	191.1 V/m
Grid 7 M3	Grid 8 M3	Grid 9 M3
201.5 V/m	209.7 V/m	188.4 V/m



$$0 \text{ dB} = 211.8 \text{ V/m} = 46.52 \text{ dBV/m}$$

Fig B.1 HAC RF E-Field GSM 850 High

HAC RF E-Field GSM 850 Middle

Date/Time: 3/4/2013 4:49:17 PM

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 836.6 MHz Duty Cycle: 1:8.30042

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1); Calibrated: 7/18/2012

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E**Scan GSM850 Channel Mid/Hearing Aid Compatibility Test (101x101x1): Interpolated**grid: $dx=0.5000 \text{ mm}$, $dy=0.5000 \text{ mm}$

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 97.56 V/m; Power Drift = -0.02 dB

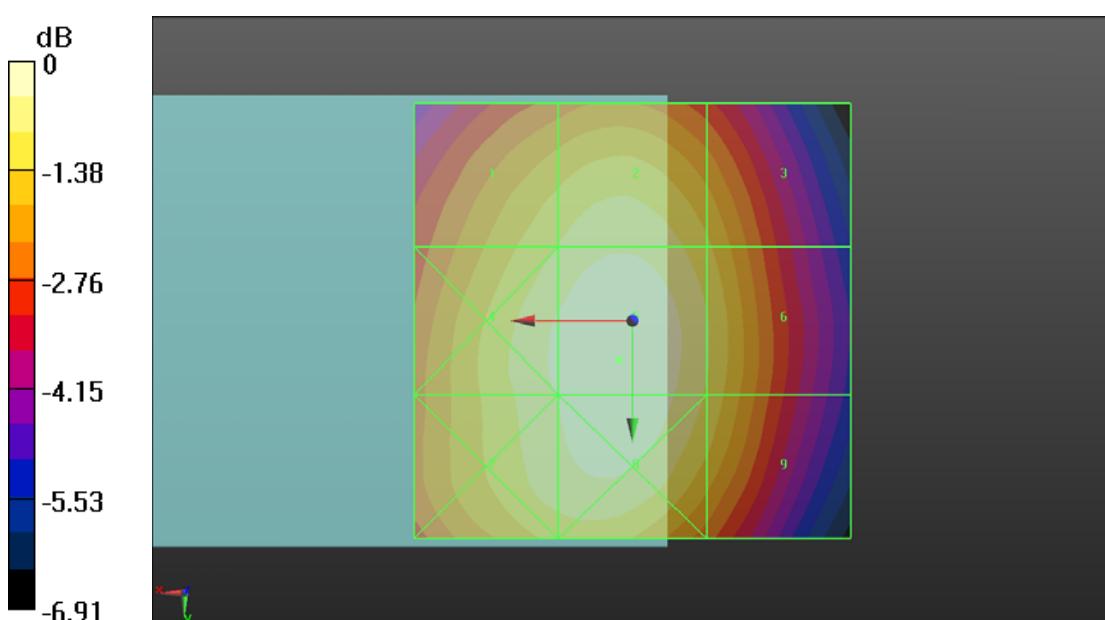
PMR not calibrated. PMF = 2.881 is applied.

E-field emissions = 205.5 V/m

Near-field category: M3 (AWF -5 dB)

PMF scaled E-field

Grid 1 M3 185.4 V/m	Grid 2 M3 193.8 V/m	Grid 3 M3 177.5 V/m
Grid 4 M3 197.4 V/m	Grid 5 M3 205.5 V/m	Grid 6 M3 186.2 V/m
Grid 7 M3 195.7 V/m	Grid 8 M3 203.9 V/m	Grid 9 M3 183.7 V/m



$$0 \text{ dB} = 205.5 \text{ V/m} = 46.26 \text{ dBV/m}$$

Fig B.2 HAC RF E-Field GSM 850 Middle

HAC RF E-Field GSM 850 Low

Date/Time: 3/4/2013 4:54:39 PM

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 824.2 MHz Duty Cycle: 1:8.30042

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1); Calibrated: 7/18/2012

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E**Scan GSM850 Channel Low/Hearing Aid Compatibility Test (101x101x1): Interpolated**grid: $dx=0.5000 \text{ mm}$, $dy=0.5000 \text{ mm}$

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 93.27 V/m; Power Drift = -0.05 dB

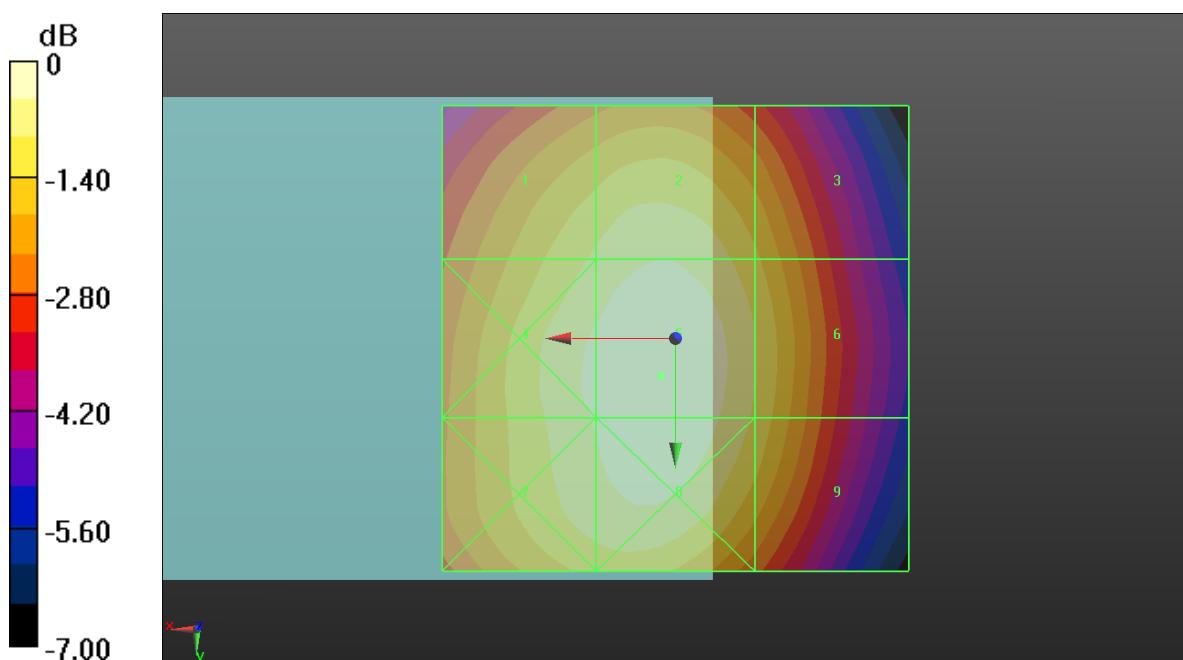
PMR not calibrated. PMF = 2.881 is applied.

E-field emissions = 196.1 V/m

Near-field category: M3 (AWF -5 dB)

PMF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
178.1 V/m	185.8 V/m	169.1 V/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
188.7 V/m	196.1 V/m	177.1 V/m
Grid 7 M3	Grid 8 M3	Grid 9 M3
187.0 V/m	194.2 V/m	174.6 V/m



$$0 \text{ dB} = 196.1 \text{ V/m} = 45.85 \text{ dBV/m}$$

Fig B.3 HAC RF E-Field GSM 850 Low

HAC RF E-Field GSM 1900 High

Date/Time: 3/4/2013 4:35:38 PM

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 1910 MHz Duty Cycle: 1:8.30042

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1); Calibrated: 7/18/2012

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E**Scan GSM1900 Channel High/Hearing Aid Compatibility Test (101x101x1): Interpolated**grid: $dx=0.5000 \text{ mm}$, $dy=0.5000 \text{ mm}$

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 29.68 V/m; Power Drift = 0.00 dB

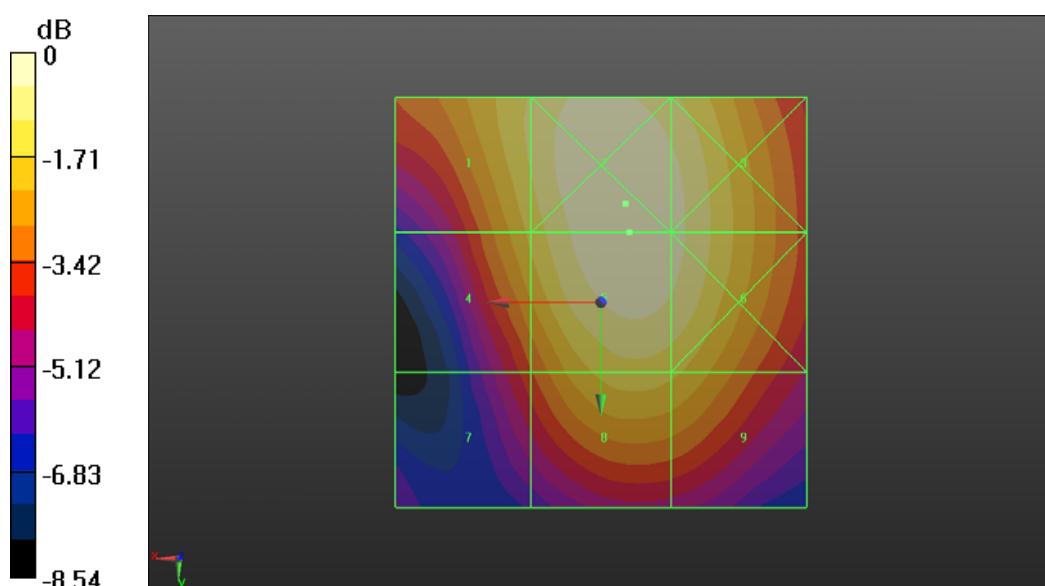
PMR not calibrated. PMF = 2.881 is applied.

E-field emissions = 67.43 V/m

Near-field category: M3 (AWF -5 dB)

PMF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
60.32 V/m	67.63 V/m	65.10 V/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
56.70 V/m	67.43 V/m	65.05 V/m
Grid 7 M4	Grid 8 M3	Grid 9 M3
45.43 V/m	57.94 V/m	56.53 V/m



$$0 \text{ dB} = 67.63 \text{ V/m} = 36.60 \text{ dBV/m}$$

Fig B.4 HAC RF E-Field GSM 1900 High

HAC RF E-Field GSM 1900 Middle

Date/Time: 3/4/2013 4:30:17 PM

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 1880 MHz Duty Cycle: 1:8.30042

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1); Calibrated: 7/18/2012

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E Scan GSM1900 Channel Mid/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 33.19 V/m; Power Drift = 0.01 dB

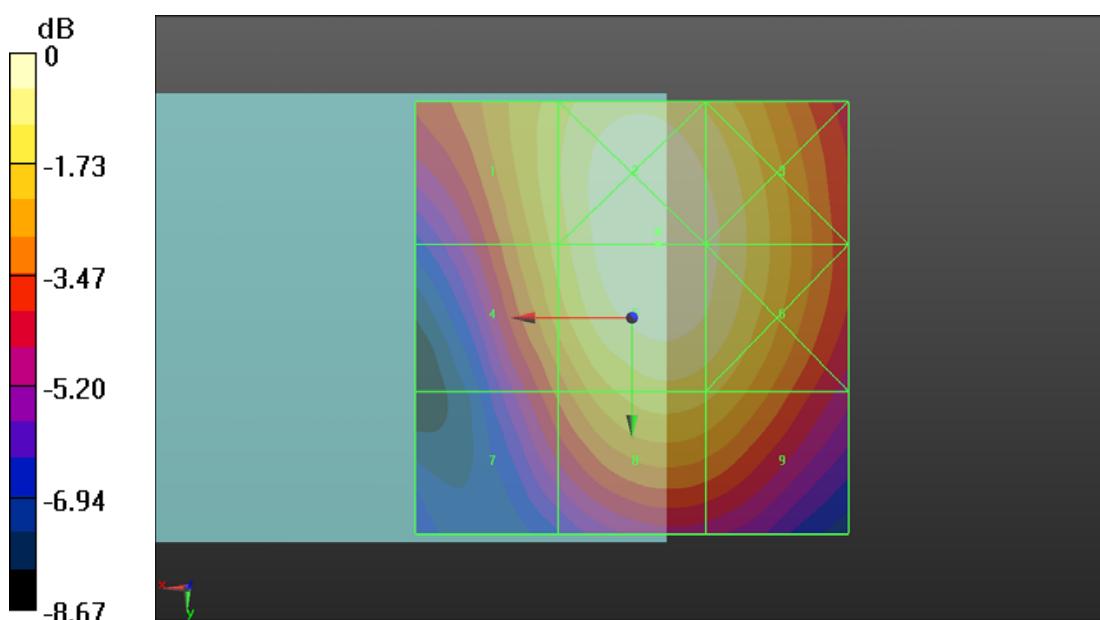
PMR not calibrated. PMF = 2.881 is applied.

E-field emissions = 74.57 V/m

Near-field category: M3 (AWF -5 dB)

PMF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
64.93 V/m	74.62 V/m	71.65 V/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
63.03 V/m	74.57 V/m	71.62 V/m
Grid 7 M3	Grid 8 M3	Grid 9 M3
51.32 V/m	64.14 V/m	62.44 V/m

**Fig B.5 HAC RF E-Field GSM 1900 Middle**

HAC RF E-Field GSM 1900 Low

Date/Time: 3/4/2013 4:19:32 PM

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 1850.2 MHz Duty Cycle: 1:8.30042

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1); Calibrated: 7/18/2012

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E**Scan GSM1900 Channel Low/Hearing Aid Compatibility Test (101x101x1): Interpolated**grid: $dx=0.5000 \text{ mm}$, $dy=0.5000 \text{ mm}$

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 37.10 V/m; Power Drift = 0.01 dB

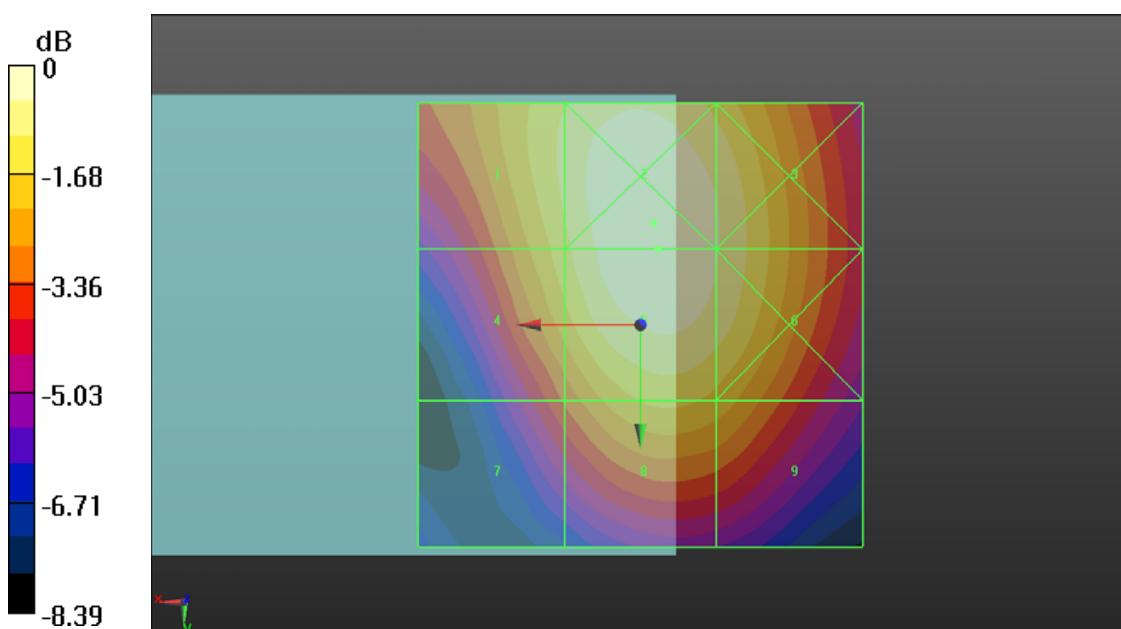
PMR not calibrated. PMF = 2.881 is applied.

E-field emissions = 83.68 V/m

Near-field category: M3 (AWF -5 dB)

PMF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
75.30 V/m	83.95 V/m	79.31 V/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
72.53 V/m	83.68 V/m	79.22 V/m
Grid 7 M3	Grid 8 M3	Grid 9 M3
57.90 V/m	70.42 V/m	67.79 V/m



$$0 \text{ dB} = 83.95 \text{ V/m} = 38.48 \text{ dBV/m}$$

Fig B.6 HAC RF E-Field GSM 1900 Low

HAC RF H-Field GSM 850 High

Date/Time: 3/4/2013 5:18:22 PM

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 848.8 MHz Duty Cycle: 1:8.30042

Probe: H3DV6 - SN6264

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan GSM850 Channel High/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: $dx=0.5000 \text{ mm}$, $dy=0.5000 \text{ mm}$

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.06700 A/m; Power Drift = 0.03 dB

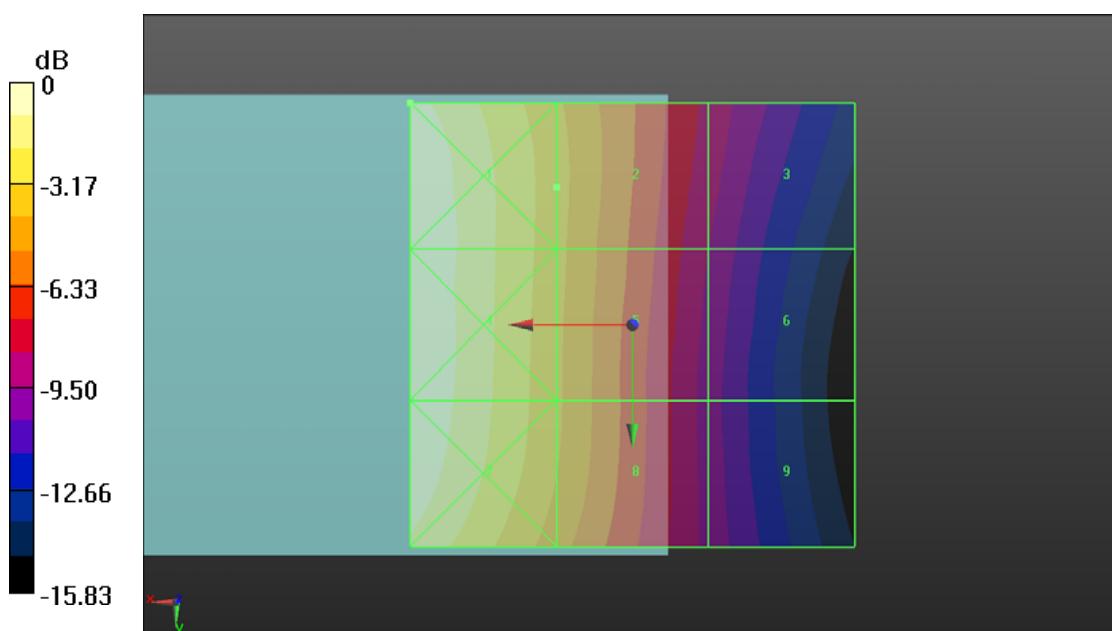
PMR not calibrated. PMF = 2.881 is applied.

H-field emissions = 0.2605 A/m

Near-field category: M4 (AWF -5 dB)

PMF scaled H-field

Grid 1 M4 0.404 A/m	Grid 2 M4 0.260 A/m	Grid 3 M4 0.148 A/m
Grid 4 M4 0.403 A/m	Grid 5 M4 0.258 A/m	Grid 6 M4 0.136 A/m
Grid 7 M4 0.402 A/m	Grid 8 M4 0.254 A/m	Grid 9 M4 0.131 A/m



$$0 \text{ dB} = 0.4036 \text{ A/m} = -7.88 \text{ dBA/m}$$

Fig B.7 HAC RF H-Field GSM 850 High

HAC RF H-Field GSM 850 Middle

Date/Time: 3/4/2013 5:13:02 PM

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 836.6 MHz Duty Cycle: 1:8.30042

Probe: H3DV6 - SN6264

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan GSM850 Channel Middle/Hearing Aid Compatibility Test**(101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm**

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.06100 A/m; Power Drift = 0.03 dB

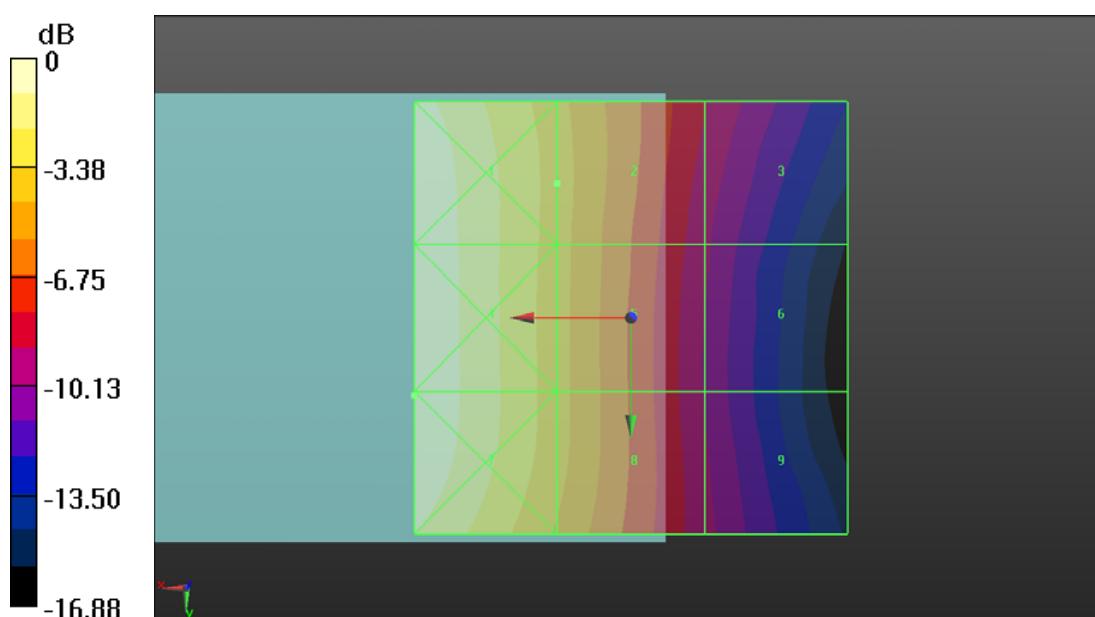
PMR not calibrated. PMF = 2.881 is applied.

H-field emissions = 0.2375 A/m

Near-field category: M4 (AWF -5 dB)

PMF scaled H-field

Grid 1 M4 0.370 A/m	Grid 2 M4 0.238 A/m	Grid 3 M4 0.134 A/m
Grid 4 M4 0.373 A/m	Grid 5 M4 0.236 A/m	Grid 6 M4 0.120 A/m
Grid 7 M4 0.373 A/m	Grid 8 M4 0.234 A/m	Grid 9 M4 0.123 A/m



$$0 \text{ dB} = 0.3728 \text{ A/m} = -8.57 \text{ dBA/m}$$

Fig B.8 HAC RF H-Field GSM 850 Middle

HAC RF H-Field GSM 850 Low

Date/Time: 3/4/2013 5:07:48 PM

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 824.2 MHz Duty Cycle: 1:8.30042

Probe: H3DV6 - SN6264

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan GSM850 Channel Low/Hearing Aid Compatibility Test (101x101x1):Interpolated grid: $dx=0.5000 \text{ mm}$, $dy=0.5000 \text{ mm}$

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.05700 A/m; Power Drift = -0.11 dB

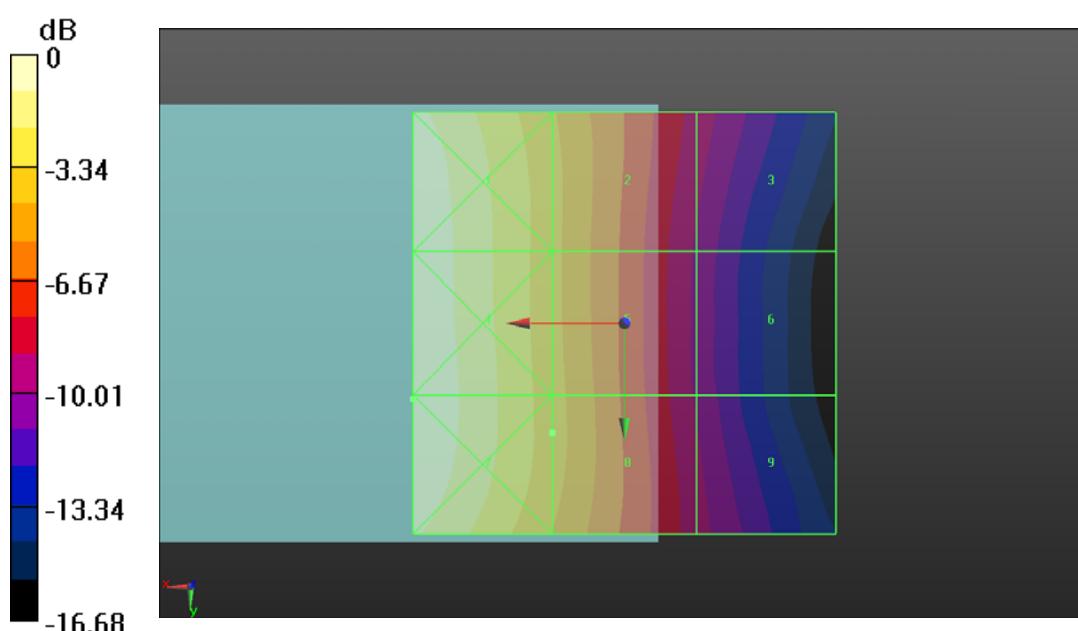
PMR not calibrated. PMF = 2.881 is applied.

H-field emissions = 0.2213 A/m

Near-field category: M4 (AWF -5 dB)

PMF scaled H-field

Grid 1 M4 0.340 A/m	Grid 2 M4 0.218 A/m	Grid 3 M4 0.120 A/m
Grid 4 M4 0.348 A/m	Grid 5 M4 0.220 A/m	Grid 6 M4 0.109 A/m
Grid 7 M4 0.348 A/m	Grid 8 M4 0.221 A/m	Grid 9 M4 0.117 A/m



$$0 \text{ dB} = 0.3482 \text{ A/m} = -9.16 \text{ dBA/m}$$

Fig B.9 HAC RF H-Field GSM 850 Low

HAC RF H-Field GSM 1900 High

Date/Time: 3/4/2013 5:24:33 PM

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 1910 MHz Duty Cycle: 1:8.30042

Probe: H3DV6 - SN6264

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan GSM1900 Channel High/Hearing Aid Compatibility Test**(101x101x1):** Interpolated grid: $dx=0.5000 \text{ mm}$, $dy=0.5000 \text{ mm}$

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.04800 A/m; Power Drift = 0.06 dB

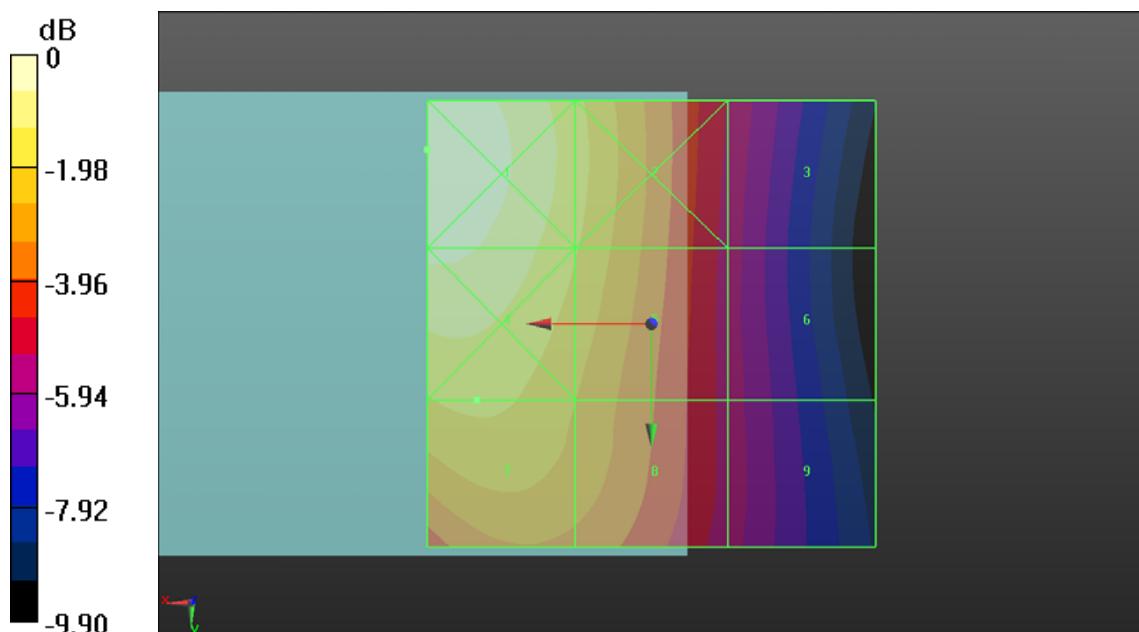
PMR not calibrated. PMF = 2.881 is applied.

H-field emissions = 0.1662 A/m

Near-field category: M3 (AWF -5 dB)

PMF scaled H-field

Grid 1 M3	Grid 2 M3	Grid 3 M4
0.205 A/m	0.169 A/m	0.112 A/m
Grid 4 M3	Grid 5 M3	Grid 6 M4
0.194 A/m	0.165 A/m	0.109 A/m
Grid 7 M3	Grid 8 M3	Grid 9 M4
0.166 A/m	0.152 A/m	0.109 A/m



$$0 \text{ dB} = 0.2050 \text{ A/m} = -13.76 \text{ dBA/m}$$

Fig B.10 HAC RF H-Field GSM 1900 High

HAC RF H-Field GSM 1900 Middle

Date/Time: 3/4/2013 5:35:17 PM

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 1880 MHz Duty Cycle: 1:8.30042

Probe: H3DV6 - SN6264

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan GSM1900 Channel Middle/Hearing Aid Compatibility Test**(101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm**

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.04800 A/m; Power Drift = 0.02 dB

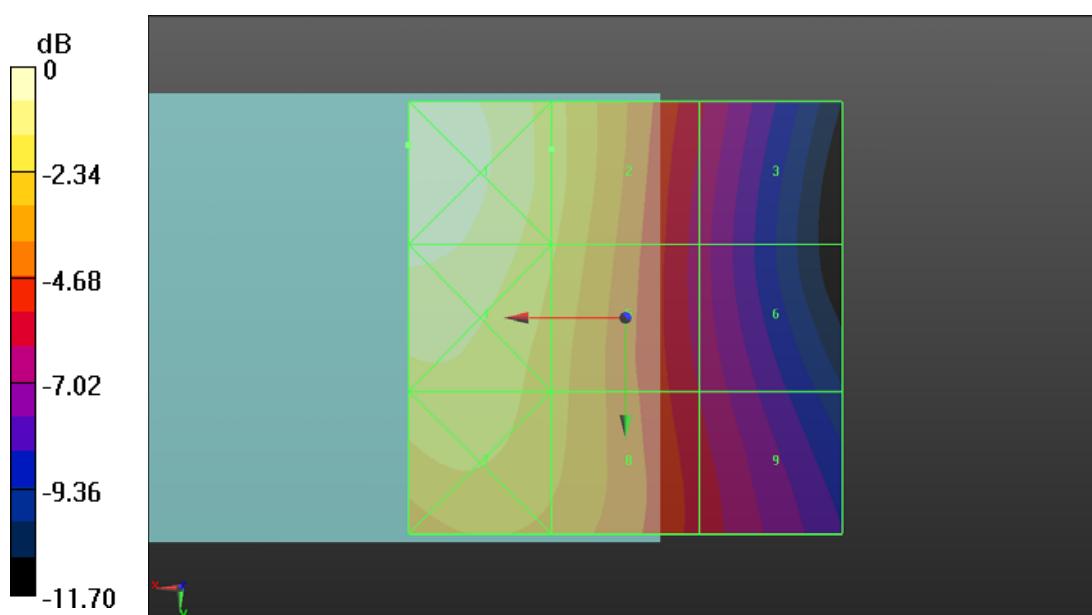
PMR not calibrated. PMF = 2.881 is applied.

H-field emissions = 0.1757 A/m

Near-field category: M3 (AWF -5 dB)

PMF scaled H-field

Grid 1 M3	Grid 2 M3	Grid 3 M4
0.220 A/m	0.176 A/m	0.110 A/m
Grid 4 M3	Grid 5 M3	Grid 6 M4
0.206 A/m	0.170 A/m	0.107 A/m
Grid 7 M3	Grid 8 M3	Grid 9 M4
0.180 A/m	0.159 A/m	0.114 A/m



$$0 \text{ dB} = 0.2198 \text{ A/m} = -13.16 \text{ dBA/m}$$

Fig B.11 HAC RF H-Field GSM 1900 Middle

HAC RF H-Field GSM 1900 Low

Date/Time: 3/4/2013 5:40:30 PM

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 1850.2 MHz Duty Cycle: 1:8.30042

Probe: H3DV6 - SN6264

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan GSM1900 Channel Low/Hearing Aid Compatibility Test**(101x101x1):** Interpolated grid: $dx=0.5000 \text{ mm}$, $dy=0.5000 \text{ mm}$

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.05200 A/m; Power Drift = 0.04 dB

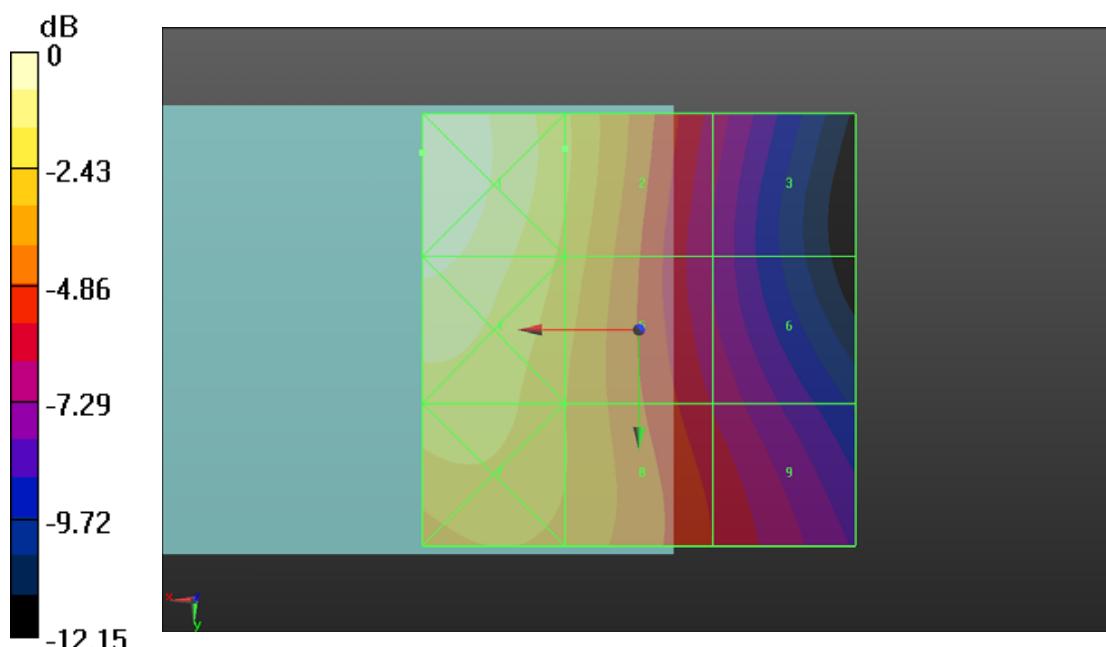
PMR not calibrated. PMF = 2.881 is applied.

H-field emissions = 0.1917 A/m

Near-field category: M3 (AWF -5 dB)

PMF scaled H-field

Grid 1 M3	Grid 2 M3	Grid 3 M4
0.248 A/m	0.192 A/m	0.115 A/m
Grid 4 M3	Grid 5 M3	Grid 6 M4
0.232 A/m	0.183 A/m	0.117 A/m
Grid 7 M3	Grid 8 M3	Grid 9 M4
0.199 A/m	0.172 A/m	0.130 A/m

**Fig B.12 HAC RF H-Field GSM 1900 Low**

Total M-rating of GSM 850 MHz Band

Date/Time: 3/04/2013

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 824.2 MHz Duty Cycle: 1:8.30042

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1); Calibrated: 7/18/2012

Probe: H3DV6 - SN6264

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E**Scan GSM850 Channel High/Hearing Aid Compatibility Test (101x101x1): Interpolated**

grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 101.0 V/m; Power Drift = -0.04 dB

PMR not calibrated. PMF = 2.881 is applied.

E-field emissions = 211.8 V/m

Near-field category: M3 (AWF -5 dB)**PMF scaled E-field**

Grid 1 M3	Grid 2 M3	Grid 3 M3
191.2 V/m	199.8 V/m	182.5 V/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
203.3 V/m	211.8 V/m	191.1 V/m
Grid 7 M3	Grid 8 M3	Grid 9 M3
201.5 V/m	209.7 V/m	188.4 V/m

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007**compliance)/H Scan GSM850 Channel High/Hearing Aid Compatibility Test**

(101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

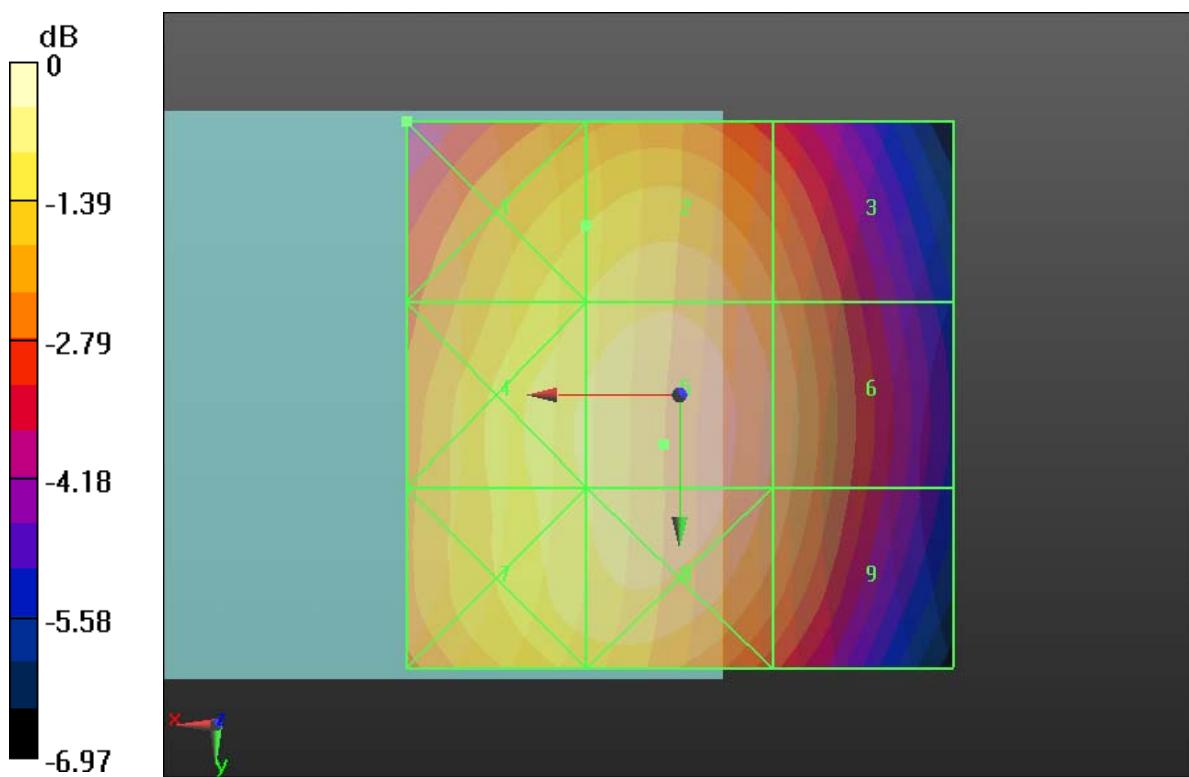
Reference Value = 0.06700 A/m; Power Drift = 0.03 dB

PMR not calibrated. PMF = 2.881 is applied.

H-field emissions = 0.2605 A/m

Near-field category: M4 (AWF -5 dB)**PMF scaled H-field**

Grid 1 M4	Grid 2 M4	Grid 3 M4
0.404 A/m	0.260 A/m	0.148 A/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
0.403 A/m	0.258 A/m	0.136 A/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
0.402 A/m	0.254 A/m	0.131 A/m



0 dB = 211.8 V/m = 46.52 dBV/m

RF RESULTS AND M-RATING	E-Field M Rating	M3 (AWF -5 dB)
	H-Field M Rating	M4 (AWF -5 dB)
	Total M Rating	M3

Fig B.13 Total M-rating of GSM 850

Total M-rating of GSM 1900 MHz Band

Date/Time: 3/04/2013

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ S/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: GSM Frequency: 1850.2 MHz Duty Cycle: 1:8.30042

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1); Calibrated: 7/18/2012

Probe: H3DV6 - SN6264

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E Scan GSM1900 Channel Low/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 37.10 V/m; Power Drift = 0.01 dB

PMR not calibrated. PMF = 2.881 is applied.

E-field emissions = 83.68 V/m

Near-field category: M3 (AWF -5 dB)**PMF scaled E-field**

Grid 1 M3	Grid 2 M3	Grid 3 M3
75.30 V/m	83.95 V/m	79.31 V/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
72.53 V/m	83.68 V/m	79.22 V/m
Grid 7 M3	Grid 8 M3	Grid 9 M3
57.90 V/m	70.42 V/m	67.79 V/m

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan GSM1900 Channel Low/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

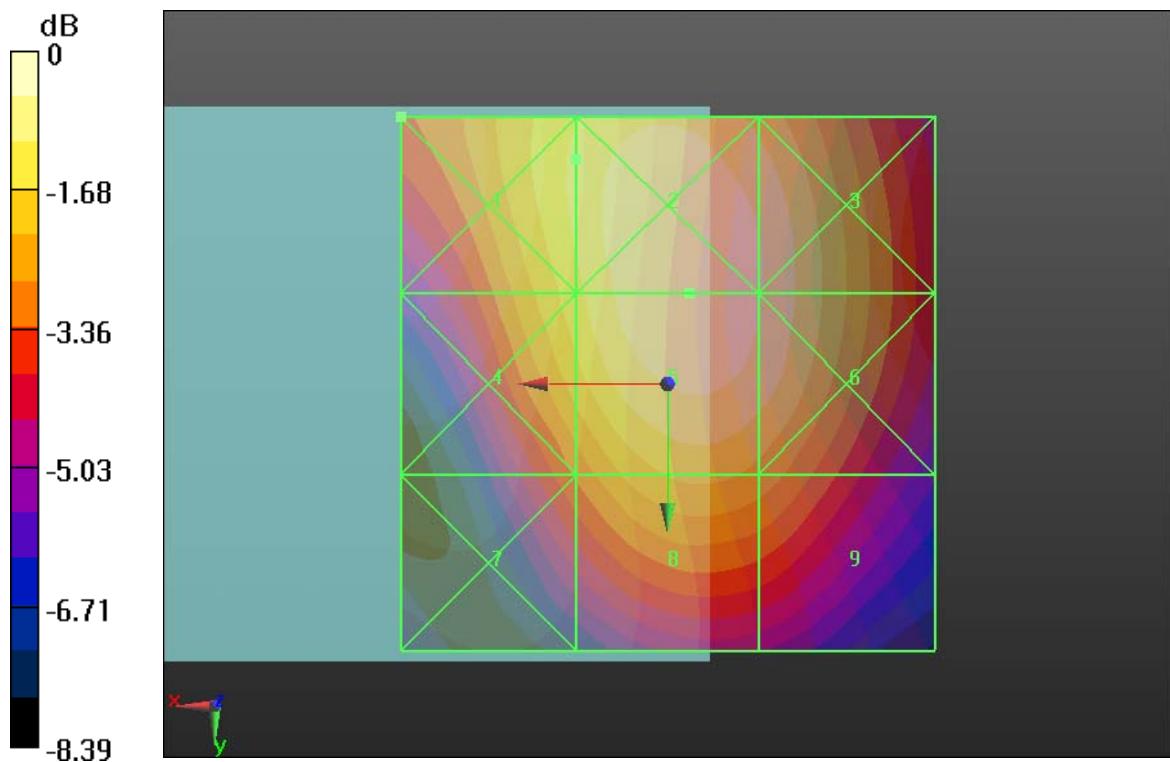
Reference Value = 0.05200 A/m; Power Drift = 0.04 dB

PMR not calibrated. PMF = 2.881 is applied.

H-field emissions = 0.1917 A/m

Near-field category: M3 (AWF -5 dB)**PMF scaled H-field**

Grid 1 M3	Grid 2 M3	Grid 3 M4
0.248 A/m	0.192 A/m	0.115 A/m
Grid 4 M3	Grid 5 M3	Grid 6 M4
0.232 A/m	0.183 A/m	0.117 A/m
Grid 7 M3	Grid 8 M3	Grid 9 M4
0.199 A/m	0.172 A/m	0.130 A/m



$$0 \text{ dB} = 83.95 \text{ V/m} = 38.48 \text{ dBV/m}$$

RF RESULTS AND M-RATING	E-Field M Rating	M3 (AWF -5 dB)
	H-Field M Rating	M3 (AWF -5 dB)
	Total M Rating	M3

Fig B.14 Total M-rating of GSM 1900

ANNEX C SYSTEM VALIDATION RESULT

E SCAN of Dipole 835 MHz

Date: 3/04/2013

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ mho/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1); Calibrated: 7/18/2012

E Scan - measurement distance from the probe sensor center to CD835 Dipole =

10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 162.8 V/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 106.9 V/m; Power Drift = 0.054 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
158.6 M4	162.8 M4	149.6 M4
88.1 M4	90.5 M4	88.2 M4
153.3 M4	162.1 M4	159.7 M4

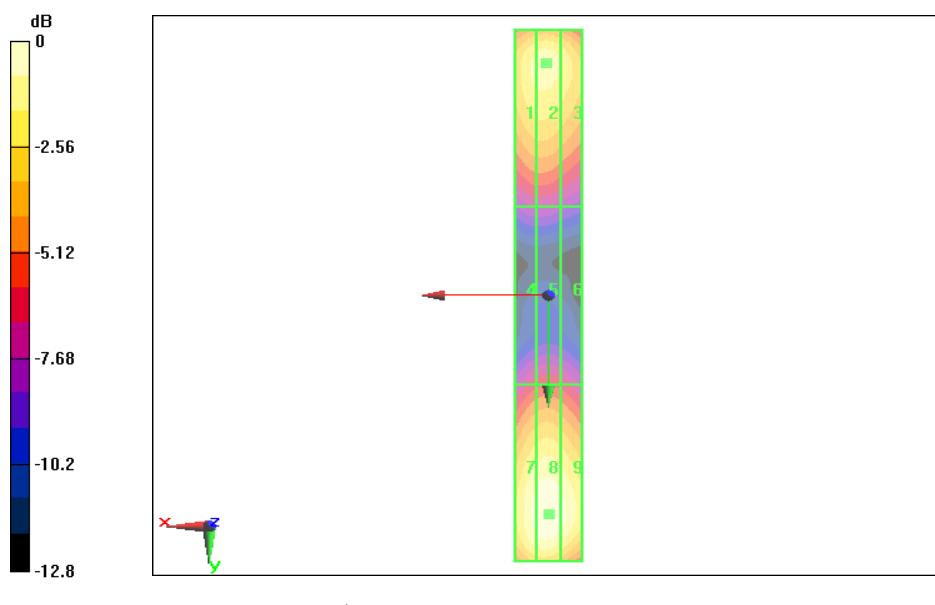


Fig B.15 E SCAN of Dipole 835 MHz

H SCAN of Dipole 835 MHz

Date: 3/04/2013

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ mho/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Probe: H3DV6 - SN6264

H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.465 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.496 A/m; Power Drift = -0.03 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.386 M4	0.406 M4	0.396 M4
Grid 4	Grid 5	Grid 6
0.434 M4	0.465 M4	0.441 M4

Grid 7	Grid 8	Grid 9
0.377 M4	0.404 M4	0.396 M4

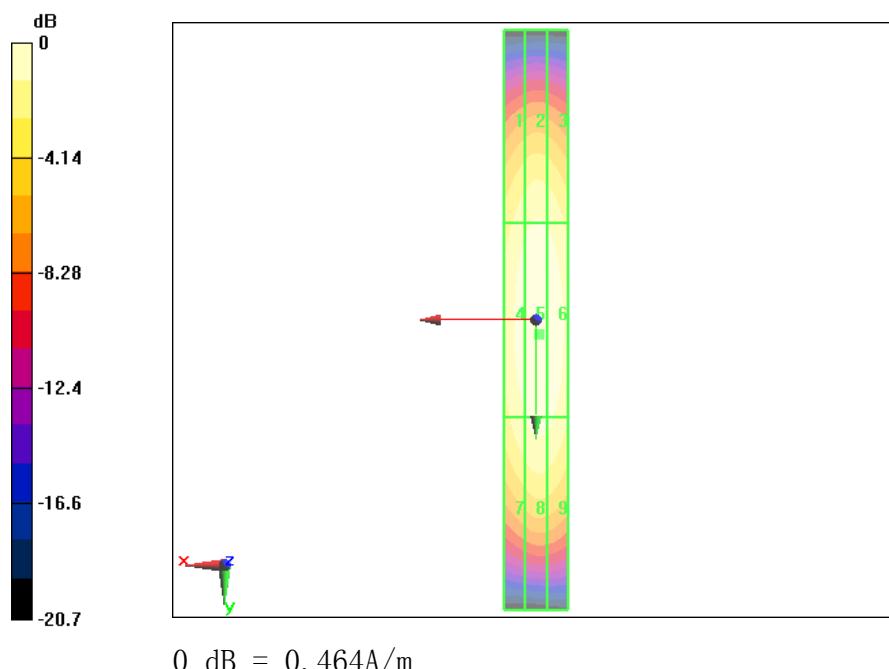


Fig B.16 H SCAN of Dipole 835 MHz

E SCAN of Dipole 1880 MHz

Date: 3/04/2013

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ mho/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: ER3DV6 - SN2424 ConvF(1, 1, 1); Calibrated: 7/18/2012

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 143.8 V/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

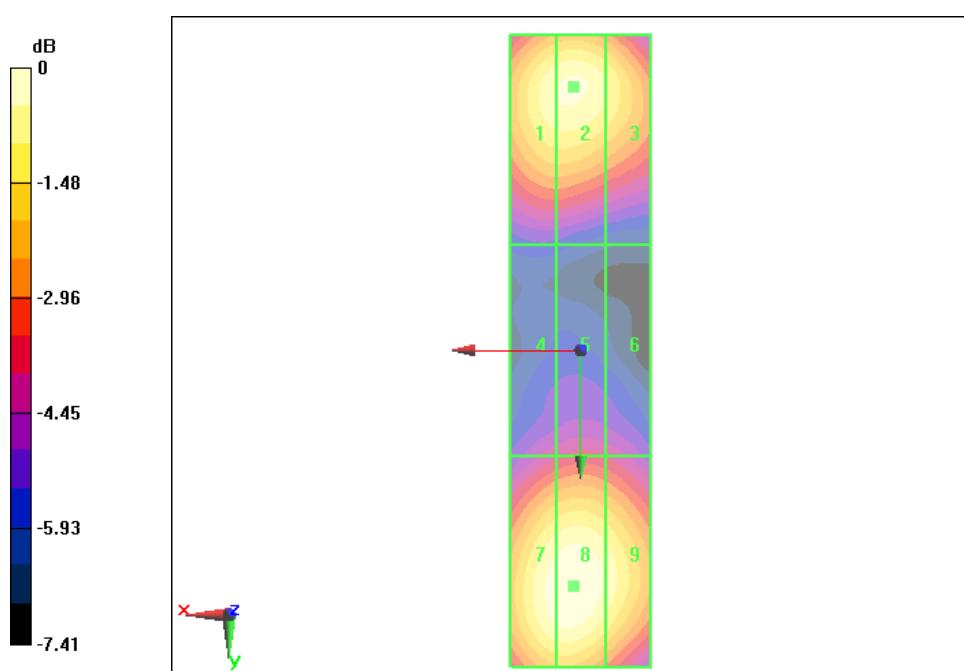
Reference Value = 161.5 V/m; Power Drift = -0.045 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
134.8 M2	139.2 M2	138.0 M2
Grid 4	Grid 5	Grid 6
90.5 M3	93.6 M3	90.7 M3

Grid 7	Grid 8	Grid 9
134.5 M2	143.8 M2	142.2 M2



$$0 \text{ dB} = 144.0 \text{ V/m}$$

Fig B.17 E SCAN of Dipole 1880 MHz

H SCAN of Dipole 1880 MHz

Date: 3/04/2013

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0 \text{ mho/m}$, $\epsilon_r = 1$; $\rho = 0 \text{ kg/m}^3$

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: H3DV6 - SN6264

H Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.463 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.491 A/m; Power Drift = 0.061 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.394 M2	0.425 M2	0.396 M2
Grid 4	Grid 5	Grid 6
0.442 M2	0.463 M2	0.454 M2

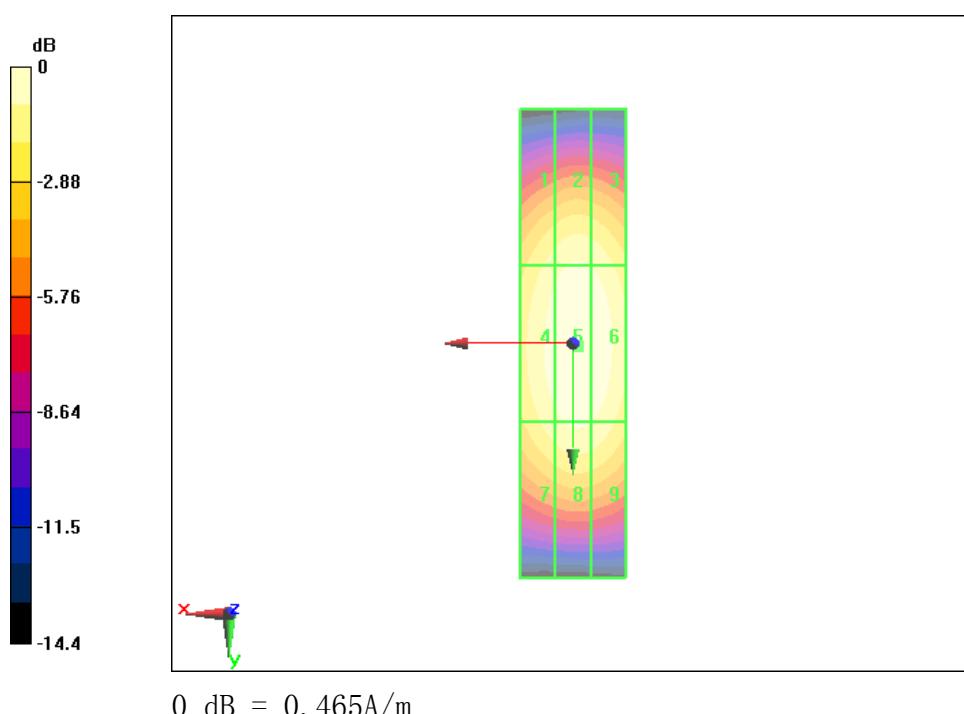


Fig B.18 H SCAN of Dipole 1880 MHz

ANNEX D PROBE CALIBRATION CERTIFICATE**E_Probe:ER3DV6**

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**Client **TMC-SZ (Auden)**Certificate No. **ER3-2424_Jul12****CALIBRATION CERTIFICATE**

Object	ER3DV6 - SN:2424 受控文件 TMC-CC-12-282-SZ02																																														
Calibration procedure(s)	QA CAL-02.v6, QA CAL-25.v4 Calibration procedure for E-field probes optimized for close near field evaluations in air																																														
Calibration date:	July 18, 2012																																														
This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.																																															
All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.																																															
Calibration Equipment used (M&TE critical for calibration)																																															
<table border="1"><thead><tr><th>Primary Standards</th><th>ID</th><th>Cal Date (Certificate No.)</th><th>Scheduled Calibration</th></tr></thead><tbody><tr><td>Power meter E4419B</td><td>GB41293874</td><td>29-Mar-12 (No. 217-01508)</td><td>Apr-13</td></tr><tr><td>Power sensor E4412A</td><td>MY41498087</td><td>29-Mar-12 (No. 217-01508)</td><td>Apr-13</td></tr><tr><td>Reference 3 dB Attenuator</td><td>SN: S5054 (3c)</td><td>27-Mar-12 (No. 217-01531)</td><td>Apr-13</td></tr><tr><td>Reference 20 dB Attenuator</td><td>SN: S5086 (20b)</td><td>27-Mar-12 (No. 217-01529)</td><td>Apr-13</td></tr><tr><td>Reference 30 dB Attenuator</td><td>SN: S5129 (30b)</td><td>27-Mar-12 (No. 217-01532)</td><td>Apr-13</td></tr><tr><td>Reference Probe ER3DV6</td><td>SN: 2328</td><td>11-Oct-11 (No. ER3-2328_Oct11)</td><td>Oct-12</td></tr><tr><td>DAE4</td><td>SN: 789</td><td>30-Jan-12 (No. DAE4-789_Jan12)</td><td>Jan-13</td></tr><tr><td>Secondary Standards</td><td>ID</td><td>Check Date (in house)</td><td>Scheduled Check</td></tr><tr><td>RF generator HP 8648C</td><td>US3642U01700</td><td>4-Aug-99 (in house check Apr-11)</td><td>In house check: Apr-13</td></tr><tr><td>Network Analyzer HP 8753E</td><td>US37390585</td><td>18-Oct-01 (in house check Oct-11)</td><td>In house check: Oct-12</td></tr></tbody></table>				Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration	Power meter E4419B	GB41293874	29-Mar-12 (No. 217-01508)	Apr-13	Power sensor E4412A	MY41498087	29-Mar-12 (No. 217-01508)	Apr-13	Reference 3 dB Attenuator	SN: S5054 (3c)	27-Mar-12 (No. 217-01531)	Apr-13	Reference 20 dB Attenuator	SN: S5086 (20b)	27-Mar-12 (No. 217-01529)	Apr-13	Reference 30 dB Attenuator	SN: S5129 (30b)	27-Mar-12 (No. 217-01532)	Apr-13	Reference Probe ER3DV6	SN: 2328	11-Oct-11 (No. ER3-2328_Oct11)	Oct-12	DAE4	SN: 789	30-Jan-12 (No. DAE4-789_Jan12)	Jan-13	Secondary Standards	ID	Check Date (in house)	Scheduled Check	RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-11)	In house check: Apr-13	Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-11)	In house check: Oct-12
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Calibrated by:	Name Claudio Leubler	Function Laboratory Technician	Signature 																																												
Approved by:	Katja Pokovic	Technical Manager																																													
Issued: July 20, 2012																																															
This calibration certificate shall not be reproduced except in full without written approval of the laboratory.																																															



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Accreditation No.: SCS 108

Glossary:

NORM _{x,y,z}	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
- CTIA Test Plan for Hearing Aid Compatibility, April 2010.

Methods Applied and Interpretation of Parameters:

- $NORM_{x,y,z}$: Assessed for E-field polarization $\vartheta = 0$ for XY sensors and $\vartheta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- $NORM(f)x,y,z = NORM_{x,y,z} * frequency_response$ (see Frequency Response Chart).
- $DCP_{x,y,z}$: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- $A_{x,y,z}; B_{x,y,z}; C_{x,y,z}, VR_{x,y,z}$: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the $NORM_x$ (no uncertainty required).

ER3DV6 – SN:2424

July 18, 2012

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2424

Parameter	Value	Description	Unit	Notes
Parameter X	1.00	Calibration Factor	None	
Parameter Y	0.00	Offset	None	
Parameter Z	0.00	Span	None	
Parameter A	0.00	Min. Value	None	
Parameter B	0.00	Max. Value	None	

Probe ER3DV6

SN:2424

Manufactured: November 12, 2007
Calibrated: July 18, 2012

Calibrated for DASY/EASY Systems
(Note: non-compatible with DASY2 system!)

ER3DV6– SN:2424

July 18, 2012

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2424**Basic Calibration Parameters**

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$)	1.52	1.53	1.87	$\pm 10.1 \%$
DCP (mV) ^B	98.6	100.0	99.8	

Modulation Calibration Parameters

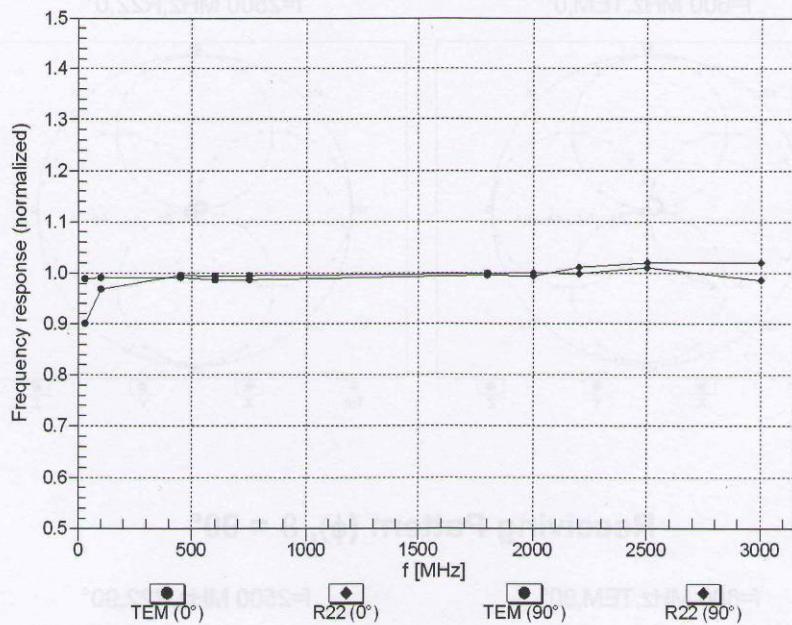
UID	Communication System Name	PAR		A dB	B dB	C dB	VR mV	Unc ^E (k=2)
0	CW	0.00	X	0.00	0.00	1.00	192.9	$\pm 4.1 \%$
			Y	0.00	0.00	1.00	207.9	
			Z	0.00	0.00	1.00	201.5	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter; uncertainty not required.^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

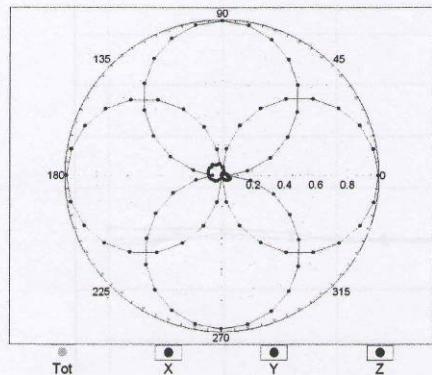
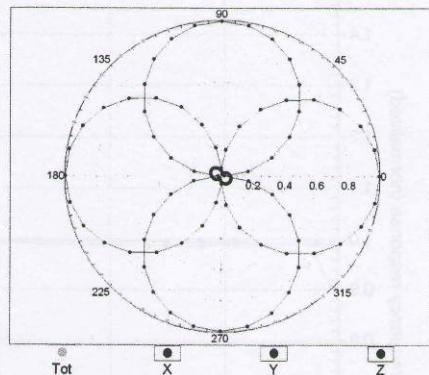
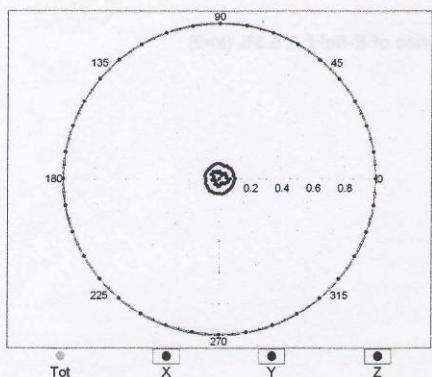
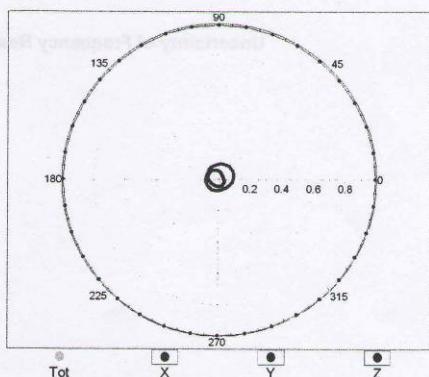
ER3DV6— SN:2424

July 18, 2012

Frequency Response of E-Field
(TEM-Cell:ifi110 EXX, Waveguide: R22)Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

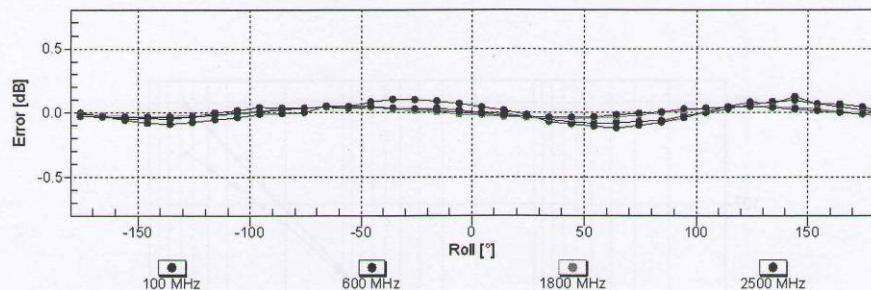
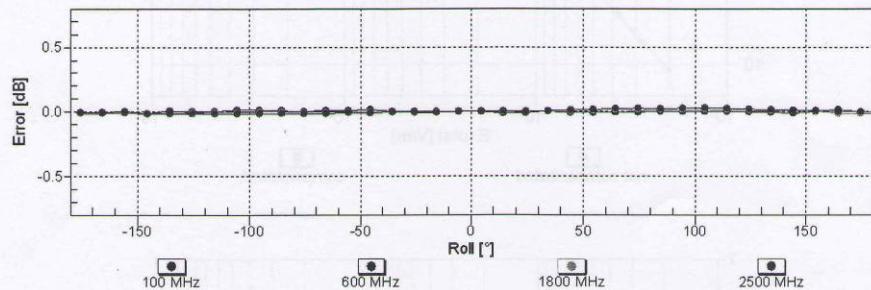
ER3DV6- SN:2424

July 18, 2012

Receiving Pattern (ϕ), $\theta = 0^\circ$ $f=600 \text{ MHz, TEM, } 0^\circ$  $f=2500 \text{ MHz, R22, } 0^\circ$ **Receiving Pattern (ϕ), $\theta = 90^\circ$** $f=600 \text{ MHz, TEM, } 90^\circ$  $f=2500 \text{ MHz, R22, } 90^\circ$ 

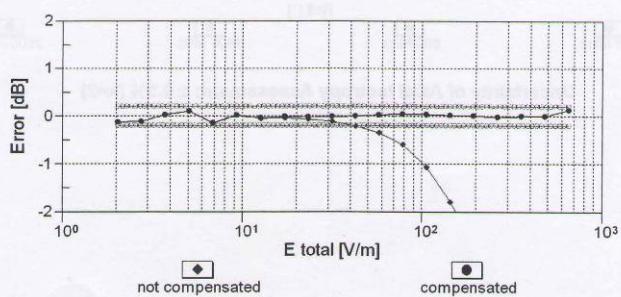
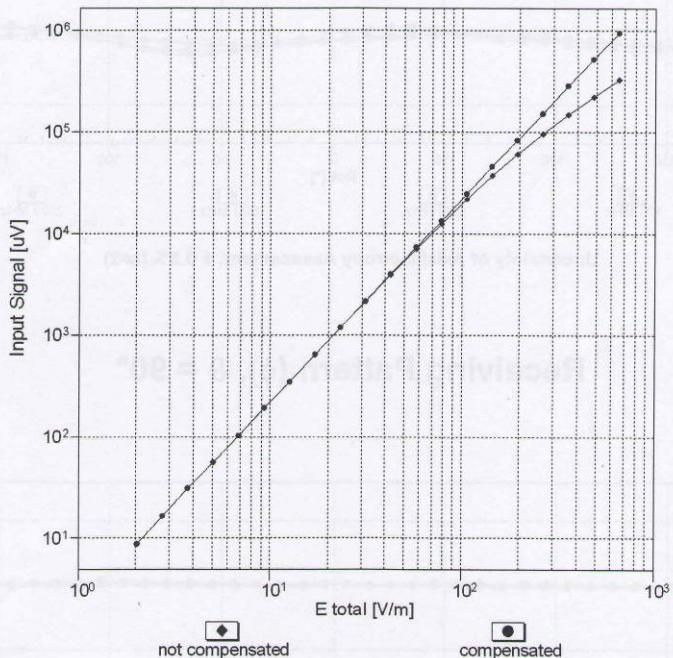
ER3DV6—SN:2424

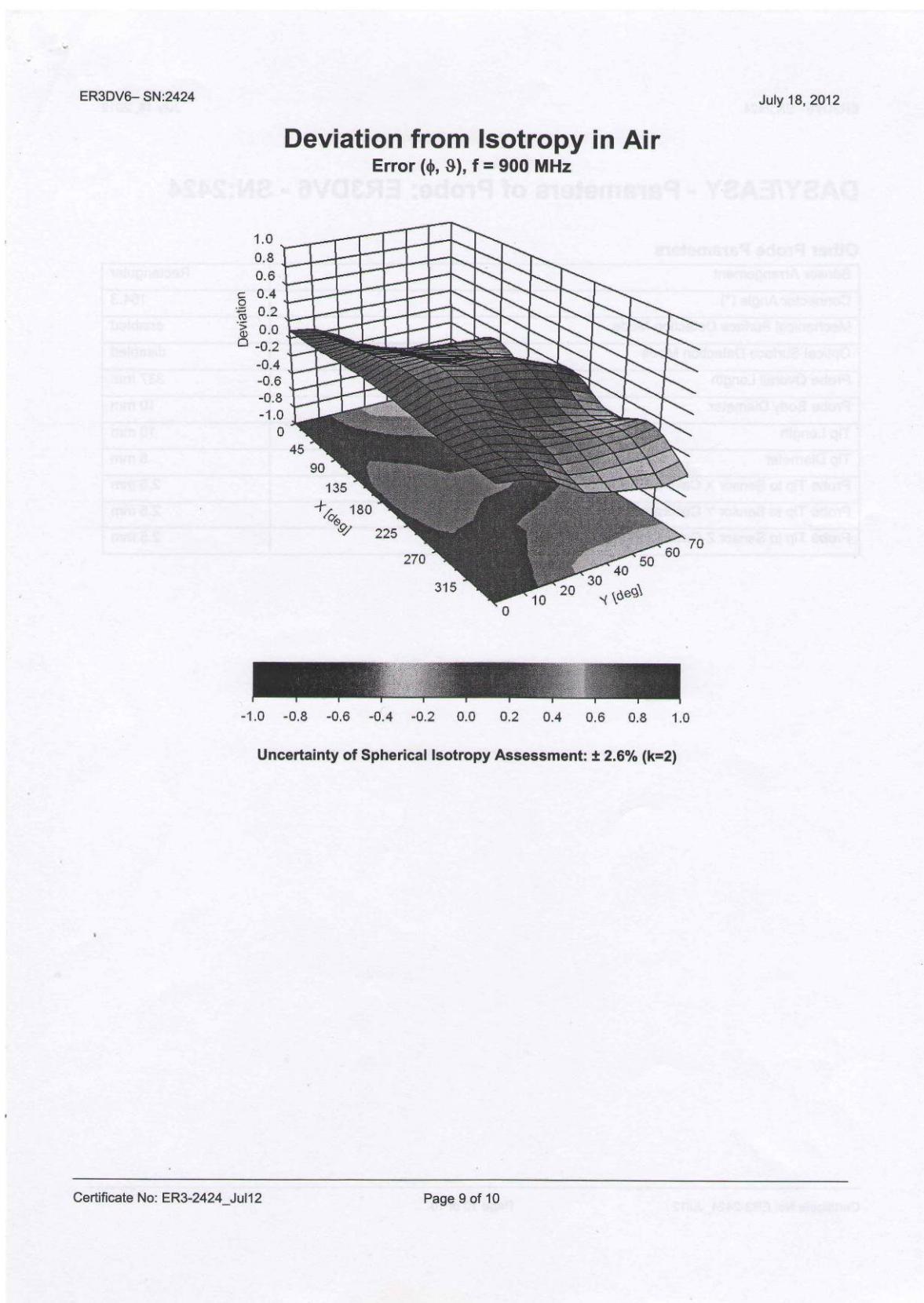
July 18, 2012

Receiving Pattern (ϕ), $\theta = 0^\circ$ **Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)****Receiving Pattern (ϕ), $\theta = 90^\circ$** **Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)**

ER3DV6– SN:2424

July 18, 2012

Dynamic Range f(E-field)
(TEM cell , f = 900 MHz)**Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)**



ER3DV6- SN:2424

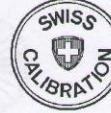
July 18, 2012

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2424**Other Probe Parameters**

Sensor Arrangement	Rectangular
Connector Angle (°)	164.3
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

H_Probe H3DV6

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TMC-SZ (Auden)** Certificate No: **H3-6264_Jul12**

CALIBRATION CERTIFICATE

Object **H3DV6 - SN:6264** TMC-CC-12-281-SZ02

Calibration procedure(s) **QA CAL-03.v6, QA CAL-25.v4**
Calibration procedure for H-field probes optimized for close near field evaluations in air

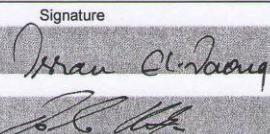
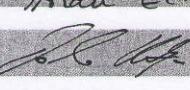
Calibration date: **July 20, 2012**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^\circ\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	29-Mar-12 (No. 217-01508)	Apr-13
Power sensor E4412A	MY41498087	29-Mar-12 (No. 217-01508)	Apr-13
Reference 3 dB Attenuator	SN: S5054 (3c)	27-Mar-12 (No. 217-01531)	Apr-13
Reference 20 dB Attenuator	SN: S5086 (20b)	27-Mar-12 (No. 217-01529)	Apr-13
Reference 30 dB Attenuator	SN: S5129 (30b)	27-Mar-12 (No. 217-01532)	Apr-13
Reference Probe H3DV6	SN: 6182	11-Oct-11 (No. H3-6182_Oct11)	Oct-12
DAE4	SN: 789	30-Jan-12 (No. DAE4-789_Jan12)	Jan-13
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-11)	In house check: Apr-13
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-11)	In house check: Oct-12

Calibrated by:	Name	Function	Signature
Calibrated by:	Israe El-Naouq	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: July 23, 2012

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Certificate No: H3-6264_Jul12 Page 1 of 10 

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Accreditation No.: SCS 108

Glossary:

NORM _{x,y,z}	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization ϕ	ϕ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.
- CTIA Test Plan for Hearing Aid Compatibility, April 2010.

Methods Applied and Interpretation of Parameters:

- $NORM_{x,y,z}$: Assessed for E-field polarization $\vartheta = 0$ for XY sensors and $\vartheta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- $X,Y,Z(f)_a0a1a2=X,Y,Z_a0a1a2*frequency_response$ (see Frequency Response Chart).
- $DCP_{x,y,z}$: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- $A_x,y,z; B_x,y,z; C_x,y,z; VR_x,y,z; A, B, C$ are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the X_a0a1a2 (no uncertainty required).



H3DV6 – SN:6264

July 20, 2012

Probe H3DV6

SN:6264

Επίσημα οι αποδεκτοί πολιτικοί τάξινοι στην Ελλάς για την πρόσβαση στην παγκόσμια αγορά.

Manufactured: September 7, 2007
Calibrated: July 20, 2012

Calibrated for DASY/EASY Systems
(Note: non-compatible with DASY2 system!)

H3DV6- SN:6264

July 20, 2012

DASY/EASY - Parameters of Probe: H3DV6 - SN:6264**Basic Calibration Parameters**

		Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (A/m / √(mV))	a0	2.48E-003	2.55E-003	2.95E-003	± 5.1 %
Norm (A/m / √(mV))	a1	-7.25E-005	-6.92E-005	-9.44E-005	± 5.1 %
Norm (A/m / √(mV))	a2	2.96E-005	8.62E-006	3.28E-005	± 5.1 %
DCP (mV) ^B		92.7	91.3	90.0	

Modulation Calibration Parameters

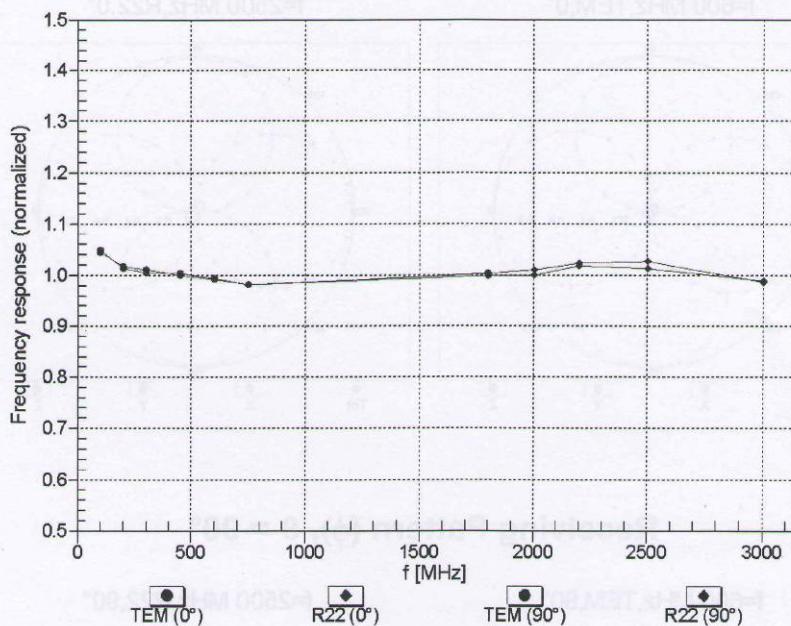
UID	Communication System Name	PAR		A dB	B dB	C dB	VR mV	Unc ^E (k=2)
0	CW	0.00	X	0.00	0.00	1.00	140.6	±4.4 %
			Y	0.00	0.00	1.00	137.4	
			Z	0.00	0.00	1.00	137.5	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter: uncertainty not required.^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

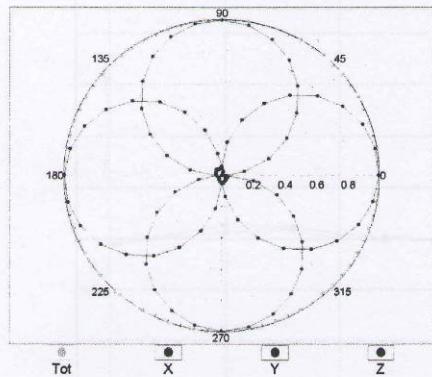
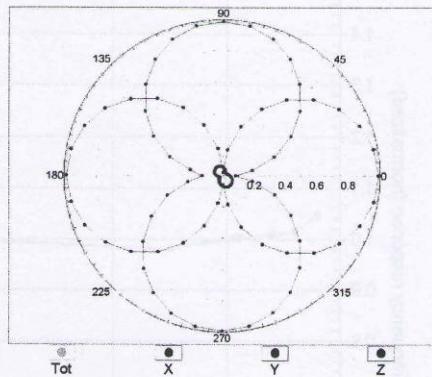
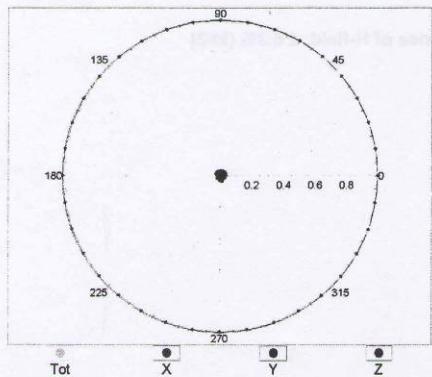
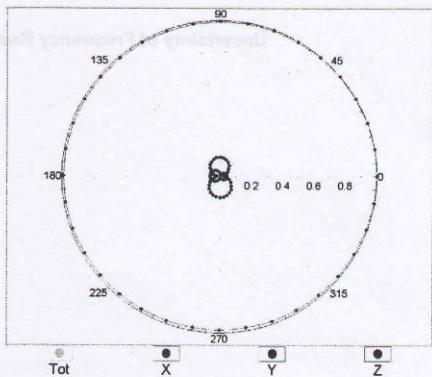
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Frequency Response of H-Field
(TEM-Cell:ifi110 EXX, Waveguide: R22)Uncertainty of Frequency Response of H-field: $\pm 6.3\%$ ($k=2$)

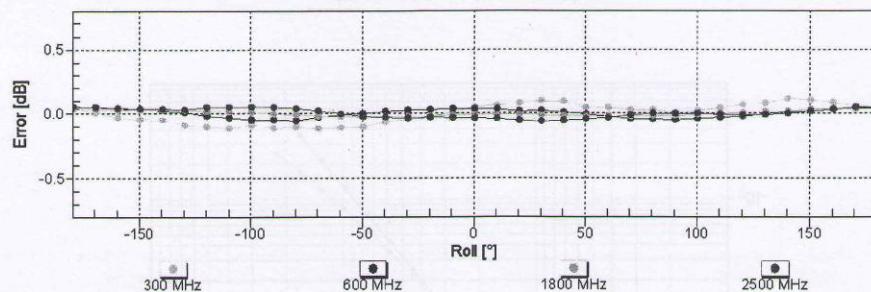
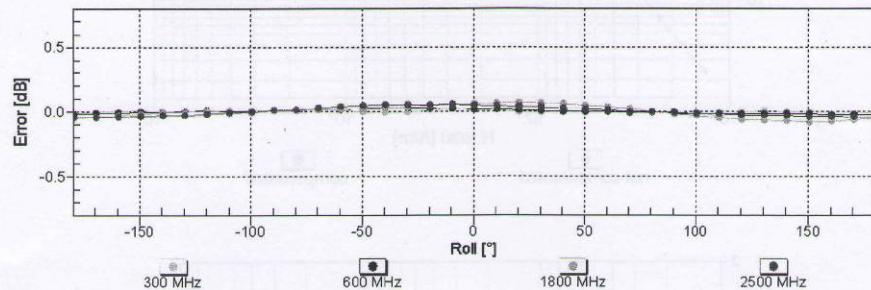
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Receiving Pattern (ϕ), $\theta = 0^\circ$ $f=600 \text{ MHz, TEM, } 0^\circ$  $f=2500 \text{ MHz, R22, } 0^\circ$ **Receiving Pattern (ϕ), $\theta = 90^\circ$** $f=600 \text{ MHz, TEM, } 90^\circ$  $f=2500 \text{ MHz, R22, } 90^\circ$ 

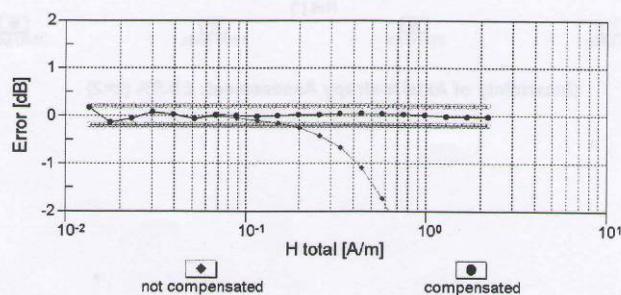
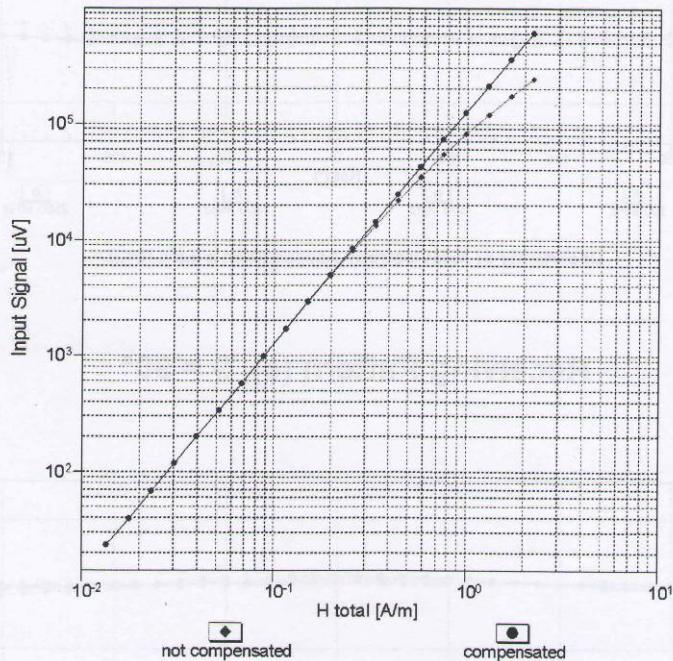
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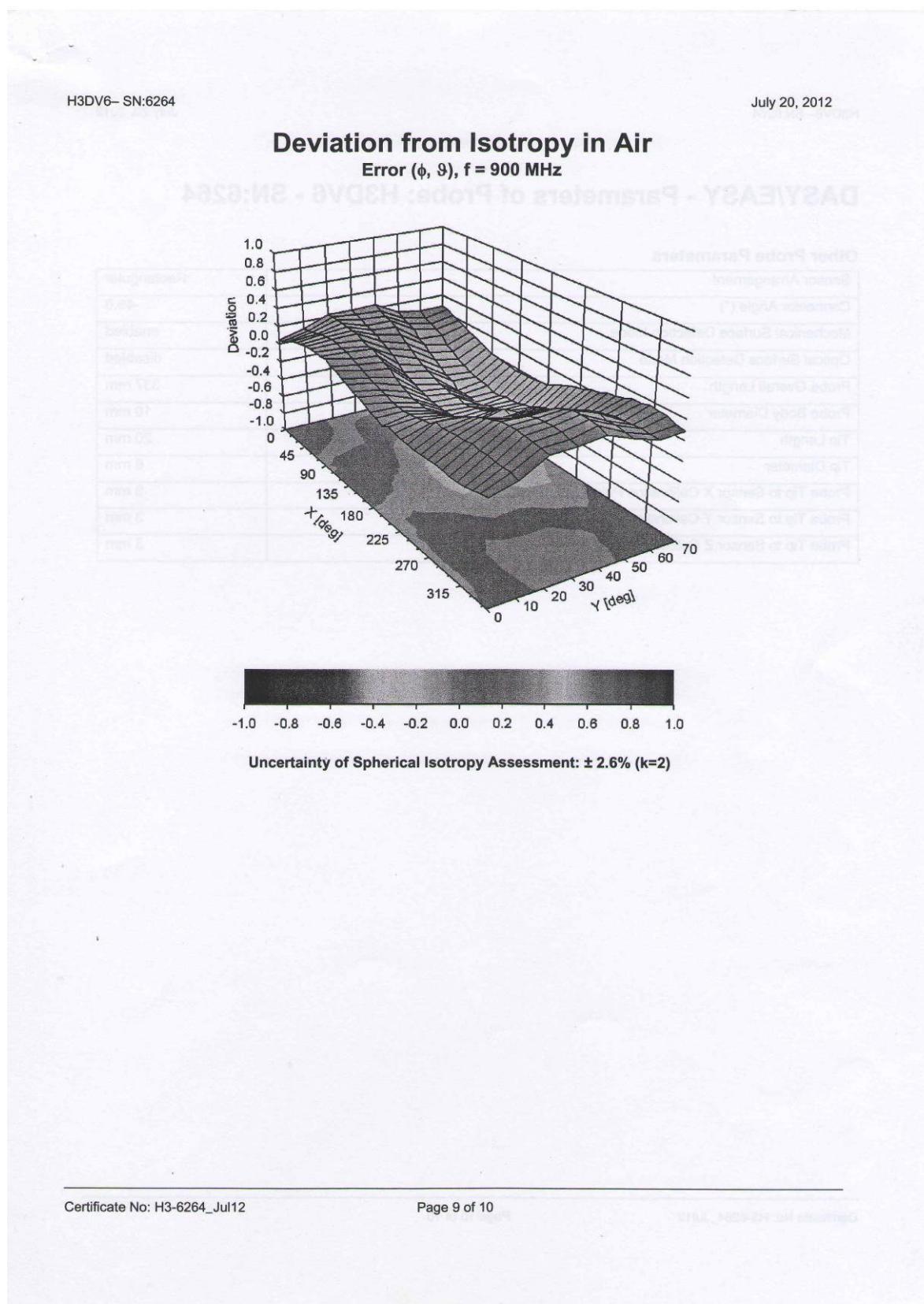
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Receiving Pattern (ϕ), $\theta = 0^\circ$ **Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)****Receiving Pattern (ϕ), $\theta = 90^\circ$** **Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)**

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Dynamic Range f(H-field)
(TEM cell, f = 900 MHz)**Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)**



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DASY/EASY - Parameters of Probe: H3DV6 - SN:6264**Other Probe Parameters**

Sensor Arrangement	Rectangular
Connector Angle (°)	-49.6
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	20 mm
Tip Diameter	6 mm
Probe Tip to Sensor X Calibration Point	3 mm
Probe Tip to Sensor Y Calibration Point	3 mm
Probe Tip to Sensor Z Calibration Point	3 mm